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SAR Test Report

Report Number: M140907

Evaluation of the SAR of Samsung Galaxy and Apple iPhones When Fitted With the Brainwave Smart Chip

Tested For: Panasales Clearance Centre Pty Ltd

Date of Issue: 24th September 2014

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1.0 GENERAL INFORMATION

Test Samples: 1. Apple iPhone 4 and 5 with and without Smart Chip
2. Samsung Galaxy 4 and 5 with and without SmartChip.

Device Category: Portable Transmitter
Test Device: Production Unit
RF exposure Category: General Public/Unaware user

Tested for: Panasales Clearance Centre Pty Ltd
Address: 14/1866 Princes Hwy Clayton
Contact: Aaron Leibovich
Phone: 03 9596 9888
Email: aaron@panasales.com.au

Test Standard/s:

1. Maximum Exposure Levels to Radiofrequency Fields – 3kHz to 300GHz, ARPANSA
2. **EN 62209-1:2006** Human exposure to radio frequency fields from hand-held and body-mounted devices-Human models, instrumentation and procedures.
   Part 1: Procedure to determine the specific absorption rate (SAR) for hand- held devices used in close proximity to the ear (frequency range 300 MHz to 3 GHz)

Summary of Results: The Cellsafe Brainwave Smart Chip was found to reduce SAR by 40.5 – 95.1% for the bands that were tested.

Test Dates: 8th September 2014 to 18th September 2014

Test Officer: Mahan Ghassempouri

Authorised Signature:

Chris Zombolas
Technical Director

2.0 DESCRIPTION OF DEVICE

2.1 Description of Test Sample

The Brainwave Smart Chip is used with iPhone 5/5s and Samsung Galaxy S4/S5 mobiles phones. The mobile phones operate in the E-GSM, DCS and WCDMA(UMTS) frequency bands and they have internal antennas. The Galaxy S4/S5 and the iPhone 5/5s were tested in accordance with EN62209-1 with and without the Smart Chip fitted while operating in the UMTS bands. Each configuration of mobile phone will be will be referred to as the Device Under Test (DUT) throughout this report. The phones were tested in the Touch position (right and left), with and without the Brainwave Smart Chip and the SAR values compared. The Tilt and Body positions were not tested at the request of the client.

Table: DUT (Device Under Test) Parameters

Operating Mode During Testing	:See Clause 2.3
Operating Mode Production Sample	: UMTS, E-GSM,
Modulation:	:GMSK for GSM/GPRS :QPSK for UMTS
Antenna type	:Internal
Applicable Head Configurations	: Touch Left Touch Right

2.2 Test sample Accessories

2.2.1 Battery Types

SAR measurements were performed with the standard iPhone 5/5s and Samsung Galaxy S4/S5 batteries.

2.3 Test Signal, Frequency and Output Power

The DUT was provided by Panasales Clearance Centre Pty Ltd. It was put into operation using a Rhodes & Schwarz Radio Communication Tester CMU200 in GSM and UMTS bands, The SAR level of the test sample was measured for the frequency bands as shown in the table below. Communication between the tester and the DUT was maintained by an air link.

Table: Test Frequencies and Power Classes

Band	Frequency MHz	Traffic Channel	Band Power Class	Nominal Power (dBm)
UMTS Band 1	1950.0	9750	3	24
UMTS Band 2	1880.0	9400	3	24
UMTS Band 5	836.6	4183	3	24
UMTS Band 8	897.6	2788	3	24

2.4 Conducted Power Measurements

The conducted power of the DUT was not measured because it did not have an accessible RF test port.

2.5 Battery Status

The DUT battery was fully charged prior to commencement of each measurement. The battery condition was monitored by measuring the RF power at a defined position inside the phantom before the commencement of each test and again after the completion of the test.

2.6 Details of Test Laboratory

2.6.1 Location

EMC Technologies Pty Ltd
176 Harrick Road
Keilor Park, (Melbourne) Victoria
Australia 3042

Telephone: +61 3 9365 1000
Facsimile: +61 3 9331 7455
email: melb@emctech.com.au
website: www.emctech.com.au

2.6.2 Accreditations

EMC Technologies Pty. Ltd. is accredited by the National Association of Testing Authorities, Australia (NATA). **NATA Accredited Laboratory Number: 5292**
Last assessed in February 2014, next scheduled assessment in February 2017

EMC Technologies Pty Ltd is NATA accredited for the following RF Human Exposure standards:

AS/NZS 2772.2 2011:	Radiofrequency Fields. **Part 2:** Principles and methods of measurement and computation - 3kHz to 300 GHz.
ACMA:	Radiocommunications (Electromagnetic Radiation — Human Exposure) Standard 2003 as amended
FCC:	FCC Knowledge Database KDB measurement procedures
EN 50360: 2001	Product standard to demonstrate the compliance of Mobile Phones with the basic restrictions related to human exposure to electromagnetic fields (300 MHz – 3 GHz)
EN 62209-1:2006	Human exposure to radio frequency fields from hand-held and body-mounted devices-Human models, instrumentation and procedures. **Part 1:** Procedure to determine the specific absorption rate (SAR) for hand-held devices used in close proximity to the ear (frequency range 300 MHz to 3 GHz)
EN 62209-2:2010	Human Exposure to radio frequency fields from hand-held and body-mounted wireless communication devices - Human models instrumentation and procedures **Part 2:** Procedure to determine the specific absorption rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz
IEEE 1528: 2013	Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate (SAR) in the Human Head Due to Wireless Communications Devices: Measurement Techniques.

Refer to NATA website www.nata.asn.au for the full scope of accreditation.

2.6.3 Environmental Factors

The measurements were performed in a shielded room with no background RF signals. The temperature in the laboratory was controlled to within 20± 1 °C, the humidity was in the range 35% to 43%. See section 0 for measured temperature and humidity. The liquid parameters were measured daily prior to the commencement of each test. Tests were performed to check that reflections within the environment did not influence the SAR measurements. The noise floor of the DASY5 SAR measurement system using either the EX3DV4 or ET3DV6 E-field probes is less than 5μV in both air and liquid mediums.

3.0 CALIBRATION AND VERIFICATION PROCEDURES AND DATA

Prior to the SAR assessment, the system verification kit was used to verify that the DASY5 was operating within its specifications. The system check was performed at the frequencies listed below using the SPEAG calibrated dipoles. The reference dipoles are highly symmetric and matched at the centre frequency for the specified liquid and distance to the phantom. The accurate distance between the liquid surface and the dipole centre is achieved with a distance holder that snaps onto the dipole. System verification is performed by feeding a known power level into a reference dipole, set at a known distance from the phantom. The measured SAR is compared to the theoretically derived level, and must be within ±10%.

3.1.1 Deviation from reference values

The EN62209 reference SAR values are derived numerically for a given phantom and dipole construction, at the frequencies listed below. These reference SAR values are obtained from the EN62209 standard and are normalized to 1W.

The SPEAG calibration reference SAR value is the SAR validation result obtained in a specific dielectric liquid using the verification dipole during calibration. The measured ten-gram SAR should be within ±10% of the expected target reference values shown in table below.

Table: Deviation from reference validation values

Date	Frequency (MHz)	Measured SAR 10g (input power = 250mW)	Measured SAR 10g (Normalized to 1W)	SPEAG Calibration Reference SAR Value 10g (mW/g)	Deviation From SPEAG 10g (%)	EN62209 Reference SAR Value 10g (mW/g)	Deviation From EN62209 10g (%)
8th September 2014	900	1.7	6.80	6.81	-0.15	6.99	-2.72
18th September 2014	1950	5.25	21.00	21.3	-1.41	20.9	0.48

Note: All reference SAR values are normalized to 1W input power.

3.1.2 Temperature and Humidity

The humidity and dielectric/ambient temperatures are recorded during the assessment of the tissue material dielectric parameters. The difference between the ambient temperature of the liquid during the dielectric measurement and the temperature during tests was less than |2|°C.

Table: Temperature and Humidity recorded for each day

Date	Ambient Temperature (°C)	Liquid Temperature (°C)	Humidity (%)
8th September 2014	19.1	19.4	35
18th September 2014	20.1	20.8	43

4.0 SAR MEASUREMENT PROCEDURE USING DASY5

The SAR evaluation was performed with the SPEAG DASY5 System (**Version 52**). A summary of the procedure follows:

a) A measurement of the SAR value at a fixed location is used as a reference value for assessing the power drop of the DUT. The SAR at this point is measured at the start of the test and then again at the end of the test.

b) The SAR distribution at the exposed side of the head or the flat section of the flat phantom is measured at a distance of 4.0 mm from the inner surface of the shell. The area covers the entire dimension of the DUT and the horizontal grid spacing is 15 mm x 15 mm. The actual largest Area Scan has dimensions of 330 mm x 180 mm surrounding the test device. Based on this data, the area of the maximum absorption is determined by Spline interpolation.

c) Around this point, a volume of 30 mm x 30 mm x 30 mm is assessed by measuring 7 x 7 x 7 points. On the basis of this data set, the spatial peak SAR value is evaluated with the following procedure:

(i) The data at the surface are extrapolated, since the centre of the dipoles is 2.7 mm away from the tip of the probe and the distance between the surface and the lowest measuring point is 4 mm. The extrapolation is based on a least square algorithm. A polynomial of the fourth order is calculated through the points in z-axes. This polynomial is then used to evaluate the points between the surface and the probe tip.

d)

(i) The maximum interpolated value is searched with a straightforward algorithm. Around this maximum the SAR values averaged over the spatial volumes (1 g and 10 g) are computed using the 3D-Spline interpolation algorithm. The 3D-Spline is composed of three one-dimensional splines with the “Not a knot”- condition (in x, y and z-direction). The volume is integrated with the trapezoidal – algorithm. One thousand points (10 x 10 x 10) are interpolated to calculate the averages.

(ii) All neighbouring volumes are evaluated until no neighbouring volume with a higher average value is found.

(iii) The SAR value at the same location as in Step (a) is again measured and the power drift is recorded.

5.0 MEASUREMENT UNCERTAINTY

The uncertainty analysis is based on the template listed in the EN 62209-1 and EN62209-2 for both Handset SAR tests and Validation uncertainty. The measurement uncertainty of a specific device is evaluated independently and the total uncertainty for both evaluations (95% confidence level) must be less than 30%.

Table: Uncertainty Budget for DASY5 Version 52 – DUT SAR test

Error Description	Uncert. Value	Prob. Dist.	Div.	C_i (1g)	C_i (10g)	1g u_i	10g u_i	v_i
Measurement System								
Probe Calibration	6	N	1.00	1	1	6.00	6.00	∞
Axial Isotropy	4.7	R	1.73	0.7	0.7	1.90	1.90	∞
Hemispherical Isotropy	9.6	R	1.73	0.7	0.7	3.88	3.88	∞
Boundary Effects	1	R	1.73	1	1	0.58	0.58	∞
Linearity	4.7	R	1.73	1	1	2.71	2.71	∞
System Detection Limits	1	R	1.73	1	1	0.58	0.58	∞
Modulation response	2.4	R	1.73	1	1	1.39	1.39	∞
Readout Electronics	0.3	N	1.00	1	1	0.30	0.30	∞
Response Time	0.8	R	1.73	1	1	0.46	0.46	∞
Integration Time	2.6	R	1.73	1	1	1.50	1.50	∞
RF Ambient Noise	3	R	1.73	1	1	1.73	1.73	∞
RF Ambient Reflections	3	R	1.73	1	1	1.73	1.73	∞
Probe Positioner	0.4	R	1.73	1	1	0.23	0.23	∞
Probe Positioning	2.9	R	1.73	1	1	1.67	1.67	∞
Post Processing	2	R	1.73	1	1	1.15	1.15	∞
Test Sample Related								
Power Scaling	0	R	1.73	1	1	0.00	0.00	∞
Test Sample Positioning	2.9	N	1.00	1	1	2.90	2.90	145
Device Holder Uncertainty	3.6	N	1.00	1	1	3.60	3.60	5
Output Power Variation – SAR Drift Measurement	4.71	R	1.73	1	1	2.72	2.72	∞
Phantom and Setup								
Phantom Uncertainty	7.6	R	1.73	1	1	4.39	4.39	∞
Liquid Conductivity – Deviation from target values	5	R	1.73	0.64	0.43	1.85	1.24	∞
Liquid Permittivity – Deviation from target values	5	R	1.73	0.6	0.49	1.73	1.41	∞
Liquid Conductivity – Measurement uncertainty	2.5	N	1.00	0.64	0.43	1.60	1.08	∞
Liquid Permittivity – Measurement uncertainty	2.5	N	1.00	0.6	0.49	1.50	1.23	∞
Temp.unc. - Conductivity	3.4	R	1.73	0.78	0.71	1.53	1.39	∞
Temp. unc. - Permittivity	0.4	R	1.73	0.23	0.26	0.05	0.06	∞
Combined standard Uncertainty (u_c)						11.8	11.6	
Expanded Uncertainty (95% CONFIDENCE LEVEL)			k= 2			23.6	23.1	

Estimated total measurement uncertainty for the DASY5 measurement system was ±11.6%. The extended uncertainty (K = 2) was assessed to be ±23.1% based on 95% confidence level. The uncertainty is not added to the measurement result.

Table: Uncertainty Budget for DASY5 Version 52 – Validation

Error Description	Uncert. Value	Prob. Dist.	Div.	C_i (1g)	C_i (10g)	1g u_i	10g u_i	v_i
Measurement System								
Probe Calibration	6	N	1.00	1	1	6.00	6.00	∞
Axial Isotropy	4.7	R	1.73	1	1	2.71	2.71	∞
Hemispherical Isotropy	9.6	R	1.73	0	0	0.00	0.00	∞
Boundary Effects	1	R	1.73	1	1	0.58	0.58	∞
Linearity	4.7	R	1.73	1	1	2.71	2.71	∞
System Detection Limits	1	R	1.73	1	1	0.58	0.58	∞
Modulation response	0	R	1.73	1	1	0.00	0.00	∞
Readout Electronics	0.3	N	1.00	1	1	0.30	0.30	∞
Response Time	0	R	1.73	1	1	0.00	0.00	∞
Integration Time	0	R	1.73	1	1	0.00	0.00	∞
RF Ambient Noise	1	R	1.73	1	1	0.58	0.58	∞
RF Ambient Reflections	1	R	1.73	1	1	0.58	0.58	∞
Probe Positioner	0.8	R	1.73	1	1	0.46	0.46	∞
Probe Positioning	6.7	R	1.73	1	1	3.87	3.87	∞
Post Processing	2	R	1.73	1	1	1.15	1.15	∞
Dipole Related								
Deviation of exp. dipole	5.5	R	1.73	1	1	3.18	3.18	##
Dipole Axis to Liquid Dist.	2	R	1.73	1	1	1.15	1.15	##
Input power & SAR drift	3.40	R	1.73	1	1	1.96	1.96	∞
Phantom and Setup								
Phantom Uncertainty	4	R	1.73	1	1	2.31	2.31	∞
Liquid Conductivity – Deviation from target values	5	R	1.73	0.64	0.43	1.85	1.24	∞
Liquid Permittivity – Deviation from target values	5	R	1.73	0.6	0.49	1.73	1.41	∞
Liquid Conductivity – Measurement uncertainty	2.5	N	1.00	0.78	0.71	1.95	1.78	∞
Liquid Permittivity – Measurement uncertainty	2.5	N	1.00	0.26	0.26	0.65	0.65	∞
Temp.unc. - Conductivity	3.4	R	1.73	0.78	0.71	1.53	1.39	∞
Temp. unc. - Permittivity	0.4	R	1.73	0.23	0.26	0.05	0.06	∞
Combined standard Uncertainty (u_c)						10.1	9.9	
Expanded Uncertainty (95% CONFIDENCE LEVEL)			k= 2			20.2	19.8	

Estimated total measurement uncertainty for the DASY5 measurement system was ±9.9%. The extended uncertainty (K = 2) was assessed to be ±19.8% based on 95% confidence level. The uncertainty is not added to the Validation measurement result.

6.0 EQUIPMENT LIST AND CALIBRATION DETAILS

Table: SPEAG DASY5 Version 52

Equipment Type	Manufacturer	Model Number	Serial Number	Calibration Due	Used For this Test?
Robot - Six Axes	Staubli	RX90BL	N/A	Not applicable	✓
Robot Remote Control	SPEAG	CS7MB	RX90B	Not applicable	✓
SAM Phantom	SPEAG	N/A	1260	Not applicable	✓
SAM Phantom	SPEAG	N/A	1060	Not applicable	✓
Flat Phantom	AndreT	10.1	P 10.1	Not Applicable	
Flat Phantom	AndreT	9.1	P 9.1	Not Applicable	
Flat Phantom	SPEAG	ELI 4.0	1101	Not Applicable	
Data Acquisition Electronics	SPEAG	DAE3 V1	359	06-June-2015	
Data Acquisition Electronics	SPEAG	DAE3 V1	442	10-Dec-2014	✓
Probe E-Field - Dummy	SPEAG	DP1	N/A	Not applicable	
Probe E-Field	SPEAG	ET3DV6	1380	13-Dec-2014	✓
Probe E-Field	SPEAG	ET3DV6	1377	10-June-2015	
Probe E-Field	SPEAG	ES3DV6	3029	Not Used	
Probe E-Field	SPEAG	EX3DV4	3956	13-June-2015	
Probe E-Field	SPEAG	EX3DV4	3657	17-Dec-2014	
Validation Source 150 MHz	SPEAG	CLA150	4003	3-Dec-2016	
Antenna Dipole 900 MHz	SPEAG	D900V2	047	22-June-2015	✓
Antenna Dipole 1800 MHz	SPEAG	D1800V2	242	20-June-2015	
Antenna Dipole 1950 MHz	SPEAG	D1950V3	1113	6-Dec -2015	✓
Antenna Dipole 2300 MHz	SPEAG	D2300V2	1032	22-Aug-2016	
Antenna Dipole 2450 MHz	SPEAG	D2450V2	724	04-Dec-2015	
Antenna Dipole 2600 MHz	SPEAG	D2600V2	1044	13-Dec-2016	
Antenna Dipole 3500 MHz	SPEAG	D3500V2	1002	13-July-2013	
Antenna Dipole 5600 MHz	SPEAG	D5GHzV2	1008	16-Dec-2014	
RF Amplifier	EIN	603L	N/A	*In test	
RF Amplifier	Mini-Circuits	ZHL-42	N/A	*In test	✓
RF Amplifier	Mini-Circuits	ZVE-8G	N/A	*In test	
Synthesized signal generator	Hewlett Packard	ESG-D3000A	GB37420238	*In test	✓
RF Power Meter	Hewlett Packard	437B	3125012786	28-Aug-2014	✓
RF Power Sensor 0.01 - 18 GHz	Hewlett Packard	8481H	1545A01634	29-Aug-2014	✓
RF Power Meter	Rohde & Schwarz	NRP	101415	18-Sept-2014	
RF Power Sensor	Rohde & Schwarz	NRP - Z81	100174	18-Sept-2014	
RF Power Meter Dual	Hewlett Packard	435A	1733A05847	*In test	✓
RF Power Sensor	Hewlett Packard	8482A	2349A10114	*In test	✓
Network Analyser	Hewlett Packard	8714B	GB3510035	25-Sept-2014	
Network Analyser	Hewlett Packard	8753ES	JP39240130	6-Nov-2014	✓
Dual Directional Coupler	Hewlett Packard	778D	1144 04700	*In test	
Dual Directional Coupler	NARDA	3022	75453	*In test	✓

* Calibrated during the test for the relevant parameters.

7.0 SAR TEST METHOD

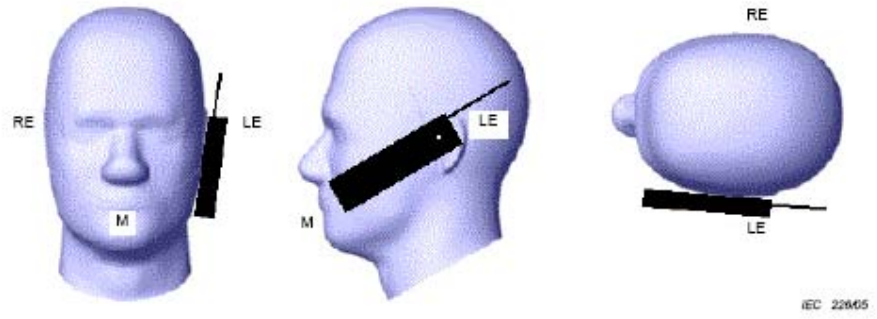
7.1 Description of the Test Positions (Head Sections)

The SAR measurements are performed on the left and right sides of the head in the Touch positions (with and without Brainwave Smart Chip) using the centre frequency of the operating band selected by the customer. The configuration giving the maximum mass-averaged SAR is used to test the low-end and high-end frequencies of the transmitting band.
See Appendix A for photos of test positions.

7.1.1 "Touch Position"

The device was positioned with the vertical centre line of the body of the device and the horizontal line crossing the centre of the earpiece in a plane parallel to the sagittal plane of the phantom. While maintaining the device in this plane, the vertical centre line was aligned with the reference plane containing the three ear and mouth reference points. (Left Ear, Right Ear and Mouth). The centre of the earpiece was then aligned with the Right Ear and Left Ear.

The Mobile Phone was then moved towards the phantom with the earpiece aligned with the line between the Left Ear and the Right Ear, until the Mobile Phone just touched the ear. With the device maintained in the reference plane, and the Mobile Phone in contact with the ear, the bottom of the Mobile Phone was moved until the front side of the Mobile Phone was in contact with the cheek of the phantom, or until contact with the ear was lost.



7.2 ARPANSA RF Exposure Limits for ACMA (Australia) and EN 50360

Table: SAR Exposure Limits

Spatial Peak SAR Limits For	
Head and Partial-Body:	2.0 mW/g (averaged over any 10g cube of tissue)
Hands, Wrists, Feet and Ankles:	4.0 mW/g (averaged over 10g cube of tissue)
Spatial Average SAR Limits For	
Whole Body:	0.08 mW/g

8.0 SAR EVALUATION RESULTS

The SAR values averaged over 10 g tissue masses were determined for the sample device for the Left and Right ear configurations of the phantom. The results for 850 MHz, 900 MHz, 1900 MHz and 1950 MHz UMTS bands are given in the tables below.

The plots with the corresponding SAR distributions are contained in Appendix B of this report.

8.1 SAR Measurement Results for iPhone 5

Table: SAR Measurement Results – UMTS 850MHz

Test Position	Plot No.	Test Mode	Test Ch.	Test Freq. (MHz)	SAR (10g) mW/g	Drift (dB)	∈r (target 41.5 ±5% 39.4 to 43.6)	σ (target 0.90 ±5% 0.86 to 0.95)
Touch Left with Chip	1	WCDMA - UMTS	4183	836.6	0.028	-0.13	40.49	0.8791
Touch Right with Chip	2	WCDMA - UMTS	4183	836.6	0.027	-0.14	40.49	0.8791
Touch Left without Chip	3	WCDMA - UMTS	4183	836.6	0.470	-0.13	40.49	0.8791
Touch Right without Chip	4	WCDMA - UMTS	4183	836.6	0.431	-0.02	40.49	0.8791
System Check	5	CW	1	900	1.7	0	39.72	0.9397

Note: The uncertainty of the system (± 23.1%) has not been added to the result.

Table: SAR Measurement Results – UMTS 1900MHz

Test Position	Plot No.	Test Mode	Test Ch.	Test Freq. (MHz)	SAR (10g) mW/g	Drift (dB)	∈r (target 40.0 ±5% 38.0 to 42.0)	σ (target 1.40 ±5% 1.33 to 1.47)
Touch Right with Chip	6	WCDMA - UMTS	9400	1880	0.403	-0.18	40.81	1.368
Touch Left with Chip	7	WCDMA - UMTS	9400	1880	0.250	-0.02	40.81	1.368
Touch Right without Chip	8	WCDMA - UMTS	9400	1880	0.763	-0.17	40.81	1.368
Touch Left without Chip	9	WCDMA - UMTS	9400	1880	0.420	-0.06	40.81	1.368
System Check	10	CW	1	1950	5.25	0.05	40.67	1.416

Note: The uncertainty of the system (± 23.1%) has not been added to the result.

8.2 SAR Measurement Results for iPhone 5S

Table: SAR Measurement Results – UMTS 900MHz

Test Position	Plot No.	Test Mode	Test Ch.	Test Freq. (MHz)	SAR (10g) mW/g	Drift (dB)	∈r (target 41.5 ±5% 39.4 to 43.6)	σ (target 0.97 ±5% 0.92 to 1.02)
Touch Left with Chip	11	WCDMA - UMTS	2788	897.6	0.035	-0.2	39.74	0.9377
Touch Right with Chip	12	WCDMA - UMTS	2788	897.6	0.022	0.02	39.74	0.9377
Touch Left without Chip	13	WCDMA - UMTS	2788	897.6	0.495	-0.15	39.74	0.9377
Touch Right without Chip	14	WCDMA - UMTS	2788	897.6	0.448	0.2	39.74	0.9377

Note: The uncertainty of the system (± 23.1%) has not been added to the result.

Table: SAR Measurement Results – UMTS 2100MHz

Test Position	Plot No.	Test Mode	Test Ch.	Test Freq. (MHz)	SAR (10g) mW/g	Drift (dB)	∈r (target 40.0 ±5% 38.0 to 42.0)	σ (target 1.40 ±5% 1.33 to 1.47)
Touch Left with Chip	15	WCDMA - UMTS	9750	1950	0.046	0.11	40.67	1.416
Touch Right with Chip	16	WCDMA - UMTS	9750	1950	0.122	-0.19	40.67	1.416
Touch Left without Chip	17	WCDMA - UMTS	9750	1950	0.472	0.12	40.67	1.416
Touch Right without Chip	18	WCDMA - UMTS	9750	1950	0.775	0.07	40.67	1.416

Note: The uncertainty of the system (± 23.1%) has not been added to the result.

8.3 SAR Measurement Results for Samsung Galaxy S4

Table: SAR Measurement Results – UMTS 1900MHz

Test Position	Plot No.	Test Mode	Test Ch.	Test Freq. (MHz)	SAR (10g) mW/g	Drift (dB)	∈r (target 40.0 ±5% 38.0 to 42.0)	σ (target 1.40 ±5% 1.33 to 1.47)
Touch Left with Chip	19	WCDMA - UMTS	9400	1880	0.031	-0.13	40.81	1.368
Touch Right with Chip	20	WCDMA - UMTS	9400	1880	0.019	0.18	40.81	1.368
Touch Left without Chip	21	WCDMA - UMTS	9400	1880	0.306	-0.1	40.81	1.368
Touch Right without Chip	22	WCDMA - UMTS	9400	1880	0.176	0.09	40.81	1.368

Note: The uncertainty of the system (± 23.1%) has not been added to the result.

Table: SAR Measurement Results – UMTS 2100MHz

Test Position	Plot No.	Test Mode	Test Ch.	Test Freq. (MHz)	SAR (10g) mW/g	Drift (dB)	∈r (target 40.0 ±5% 38.0 to 42.0)	σ (target 1.40 ±5% 1.33 to 1.47)
Touch Left with Chip	23	WCDMA - UMTS	9750	1950	0.025	-0.04	40.67	1.416
Touch Right with Chip	24	WCDMA - UMTS	9750	1950	0.011	0.07	40.67	1.416
Touch Left without Chip	25	WCDMA - UMTS	9750	1950	0.322	0.15	40.67	1.416
Touch Right without Chip	26	WCDMA - UMTS	9750	1950	0.162	-0.05	40.67	1.416

Note: The uncertainty of the system (± 23.1%) has not been added to the result.

8.4 SAR Measurement Results for Samsung Galaxy S5

Table: SAR Measurement Results – UMTS 900MHz

Test Position	Plot No.	Test Mode	Test Ch.	Test Freq. (MHz)	SAR (10g) mW/g	Drift (dB)	∈r (target 41.5 ±5% 39.4 to 43.6)	σ (target 0.97 ±5% 0.92 to 1.02)
Touch Left with chip	27	WCDMA - UMTS	2788	897.6	0.219	-0.01	41.5	0.97
Touch Right with chip	28	WCDMA - UMTS	2788	897.6	0.188	-0.05	41.5	0.97
Touch Left without chip	29	WCDMA - UMTS	2788	897.6	0.411	0.06	41.5	0.97
Touch Right without chip	30	WCDMA - UMTS	2788	897.6	0.321	0.02	41.5	0.97

Note: The uncertainty of the system (± 23.1%) has not been added to the result.

Table: SAR Measurement Results – UMTS 2100MHz

Test Position	Plot No.	Test Mode	Test Ch.	Test Freq. (MHz)	SAR (10g) mW/g	Drift (dB)	∈r (target 40.0 ±5% 38.0 to 42.0)	σ (target 1.40 ±5% 1.33 to 1.47)
Touch Left with chip	31	WCDMA - UMTS	9750	1950	0.068	0.15	40.67	1.416
Touch Right with chip	32	WCDMA - UMTS	9750	1950	0.040	0.18	40.67	1.416
Touch Left without chip	33	WCDMA - UMTS	9750	1950	0.264	-0.04	40.67	1.416
Touch Right without chip	34	WCDMA - UMTS	9750	1950	0.143	0.04	40.67	1.416

Note: The uncertainty of the system (± 23.1%) has not been added to the result.

9.0 CONCLUSION

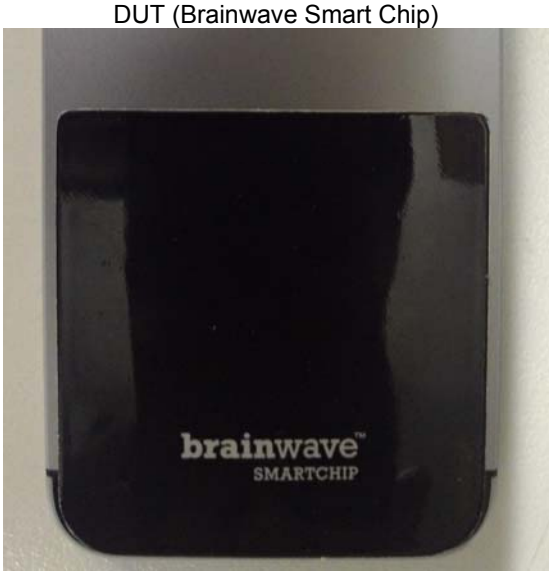
Device	Band	Test Position	Test Ch.	Test Freq. (MHz)	SAR with chip (10g) mW/g	SAR without chip (10g) mW/g	|Δ SAR|	Δ SAR Percentage (%)
iPhone 5	UMTS-850MHz	Touch Left	4183	836.6	0.028	0.470	0.442	94.0
		Touch Right	4183	836.6	0.027	0.431	0.404	93.7
	UMTS-1900MHz	Touch Left	9400	1880	0.250	0.420	0.17	**40.5**
		Touch Right	9400	1880	0.403	0.763	0.36	47.2
iPhone 5S	UMTS-900MHz	Touch Left	2788	897.6	0.035	0.495	0.46	92.9
		Touch Right	2788	897.6	0.022	0.448	0.426	**95.1**
	UMTS-2100MHz	Touch Left	9750	1950	0.046	0.472	0.426	90.3
		Touch Right	9750	1950	0.122	0.775	0.653	84.3
Samsung Galaxy S4	UMTS-1900MHz	Touch Left	9400	1880	0.031	0.306	0.275	89.9
		Touch Right	9400	1880	0.019	0.176	0.157	89.2
	UMTS-2100MHz	Touch Left	9750	1950	0.025	0.322	0.297	92.2
		Touch Right	9750	1950	0.011	0.162	0.151	93.2
Samsung Galaxy S5	UMTS-900MHz	Touch Left	2788	897.6	0.219	0.411	0.192	46.7
		Touch Right	2788	897.6	0.188	0.321	0.133	41.4
	UMTS-2100MHz	Touch Left	9750	1950	0.068	0.264	0.196	74.2
		Touch Right	9750	1950	0.040	0.143	0.103	72.0

The Brainwave Smart Chip was tested in Samsung Galaxy S4/S5 and Apple iPhone 5/5s for the Touch position at the Head, Left and Right Ear in the centre frequency of each of the bands tested.

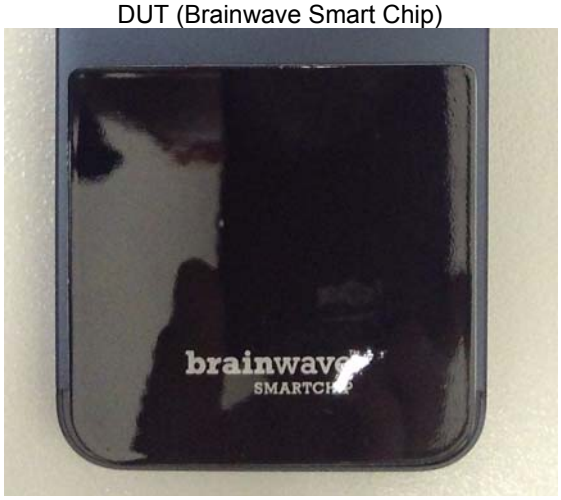
The Smart Chip resulted in a SAR reduction ranging from 40.5% to 95.1%. The Network Performance of each phone was not checked.

APPENDIX A1 Test Sample Photographs

DUT (Brainwave Smart Chip)



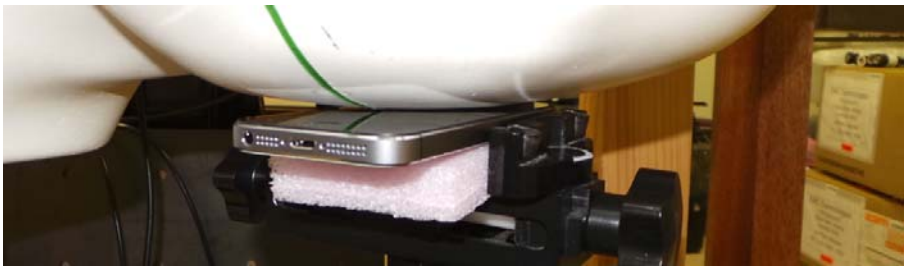
DUT (Brainwave Smart Chip)



DUT (Brainwave Smart Chip)

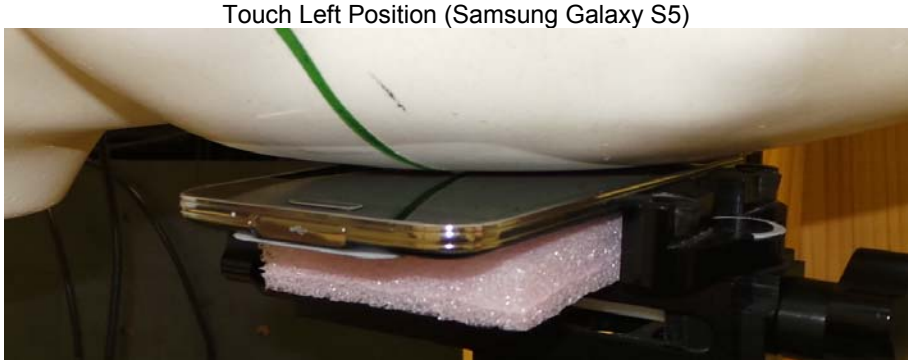
APPENDIX A2 Test Setup Photographs

Touch Left Position Touch Left Position (iPhone 5S)

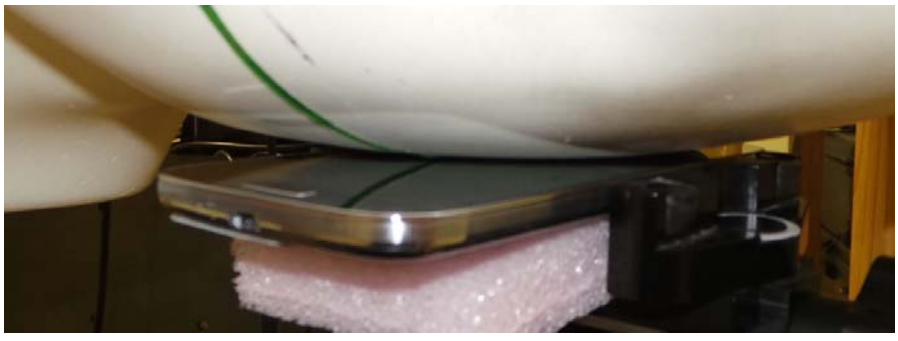


Touch Left Position (iPhone 5)

Touch Left Position (Samsung Galaxy S5)



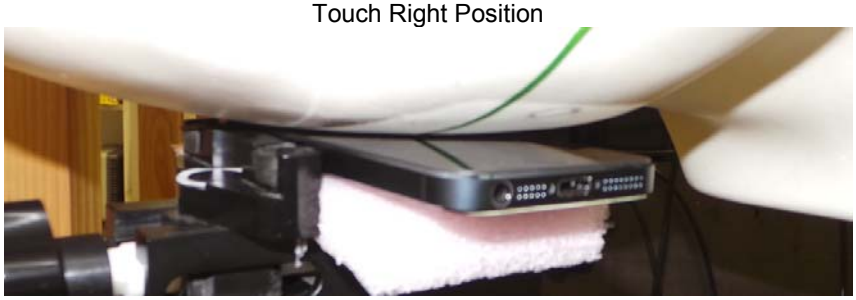
Touch Left Position (Samsung Galaxy S4)



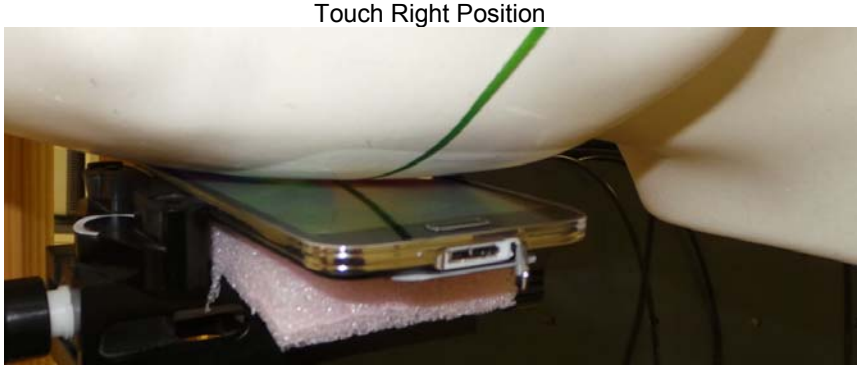
APPENDIX A3 Test Setup Photographs

Touch Right Position

Touch Right Position



Touch Right Position



Touch Right Position

APPENDIX B Plots Of The SAR Measurements

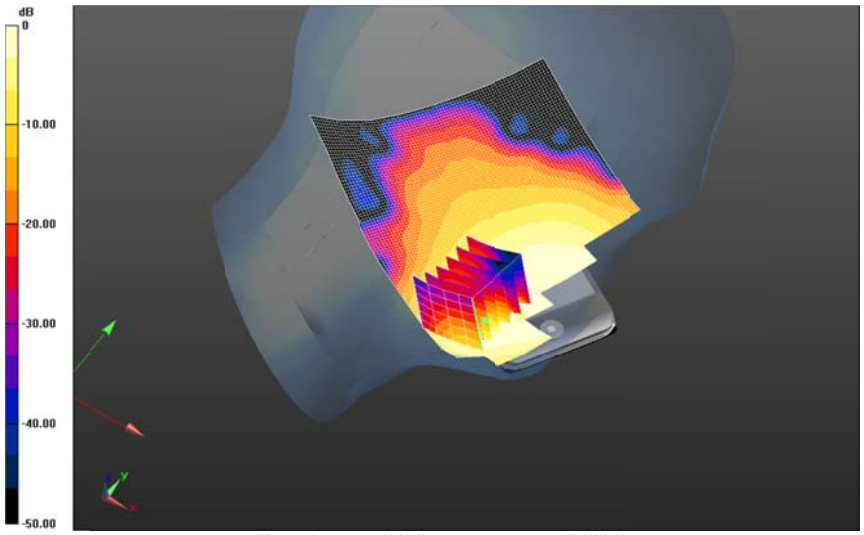
Test Lab: EMCTech Test File: M140907 - 850 MHz 3G -Antenna 1 - w chip.da52:0

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Left
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 5 850 MHz;
Frequency: 836.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=836.5 MHz; σ = 0.88 S/m; ε_r = 40.5; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.91,5.91,5.91); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 12; Type: SAM 12; Serial: 1060
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left/Channel 4183 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.048 W/kg
Touch Left/Channel 4183 Test/Zoom Scan (21x26x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 6.287 V/m; **Power Drift = -0.13 dB**
Averaged SAR: SAR(1g) = 0.047 W/kg; SAR(10g) = 0.028 W/kg
Maximum value of SAR (interpolated) = 0.069 W/kg



0 dB = 0.0478 W/kg = -13.21 dBW/kg

SAR Measurement Plot 1

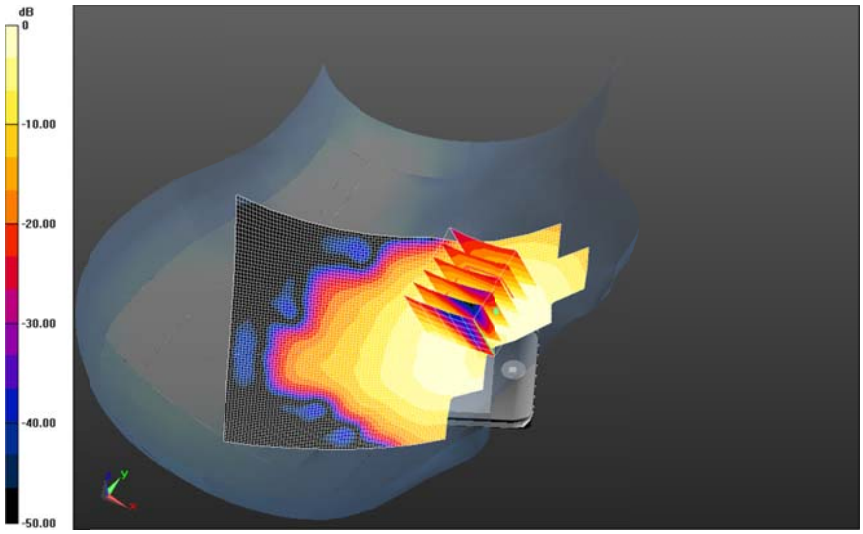
Test Lab: EMCTech Test File: M140907 - 850 MHz 3G -Antenna 1 - w chip.da52:1

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Right
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 5 850 MHz;
Frequency: 836.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=836.5 MHz; σ = 0.88 S/m; ε_r = 40.5; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.91,5.91,5.91); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 12; Type: SAM 12; Serial: 1060
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right/Channel 4183 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.045 W/kg
Touch Right/Channel 4183 Test/Zoom Scan (26x26x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 5.935 V/m; **Power Drift = -0.14 dB**
Averaged SAR: SAR(1g) = 0.043 W/kg; SAR(10g) = 0.027 W/kg
Maximum value of SAR (interpolated) = 0.059 W/kg



0 dB = 0.0445 W/kg = -13.52 dBW/kg

SAR Measurement Plot 2

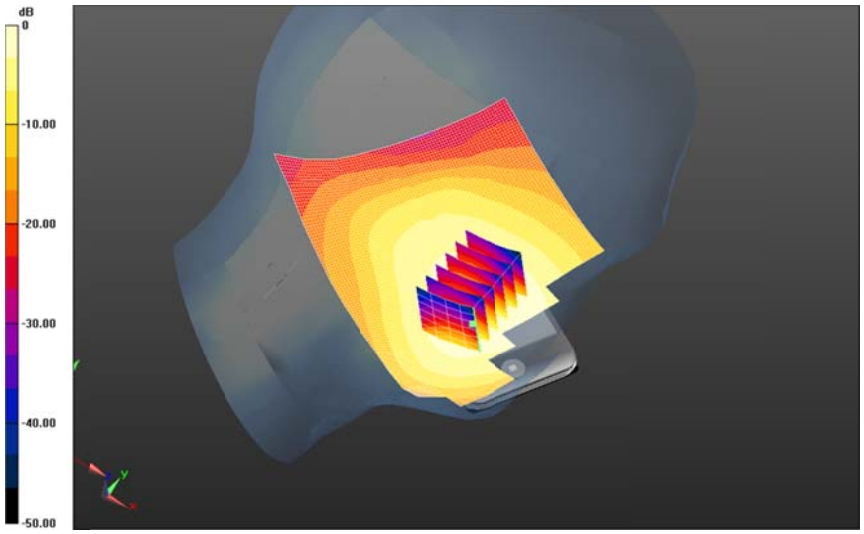
Test Lab: EMCTech Test File: M140907 - 850 MHz 3G -Antenna 1 - wo chip.da52:0

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Left
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 5 850 MHz;
Frequency: 836.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=836.5 MHz; σ = 0.88 S/m; ε_r = 40.5; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.91,5.91,5.91); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 12; Type: SAM 12; Serial: 1060
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left/Channel 4183 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.615 W/kg
Touch Left/Channel 4183 Test/Zoom Scan (21x26x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 27.994 V/m; **Power Drift = -0.13 dB**
Averaged SAR: SAR(1g) = 0.633 W/kg; SAR(10g) = 0.470 W/kg
Maximum value of SAR (interpolated) = 0.713 W/kg



0 dB = 0.615 W/kg = -2.11 dBW/kg

SAR Measurement Plot 3

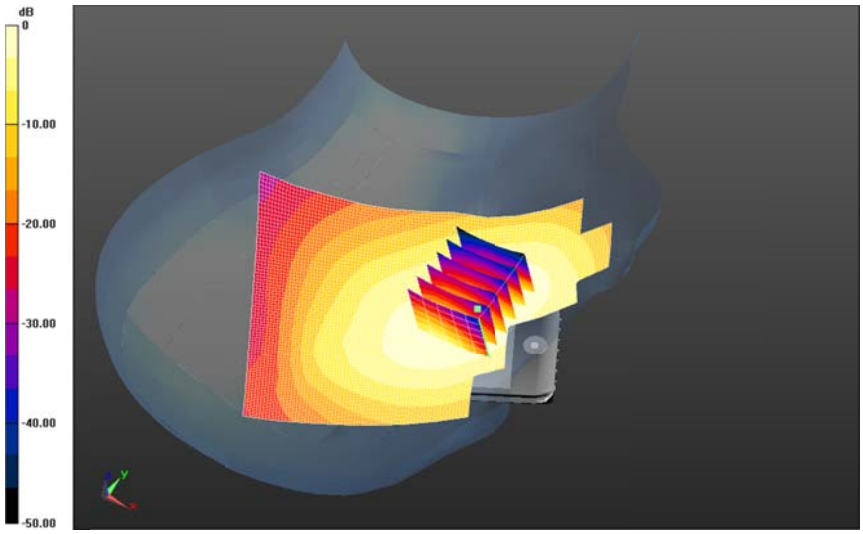
Test Lab: EMCTech Test File: M140907 - 850 MHz 3G -Antenna 1 - wo chip.da52:1

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Right
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 5 850 MHz;
Frequency: 836.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=836.5 MHz; σ = 0.88 S/m; ε_r = 40.5; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.91,5.91,5.91); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 12; Type: SAM 12; Serial: 1060
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right/Channel 4183 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.587 W/kg
Touch Right/Channel 4183 Test/Zoom Scan (26x26x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 26.154 V/m; **Power Drift = -0.02 dB**
Averaged SAR: SAR(1g) = 0.595 W/kg; SAR(10g) = 0.431 W/kg
Maximum value of SAR (interpolated) = 0.764 W/kg



0 dB = 0.587 W/kg = -2.32 dBW/kg

SAR Measurement Plot 4

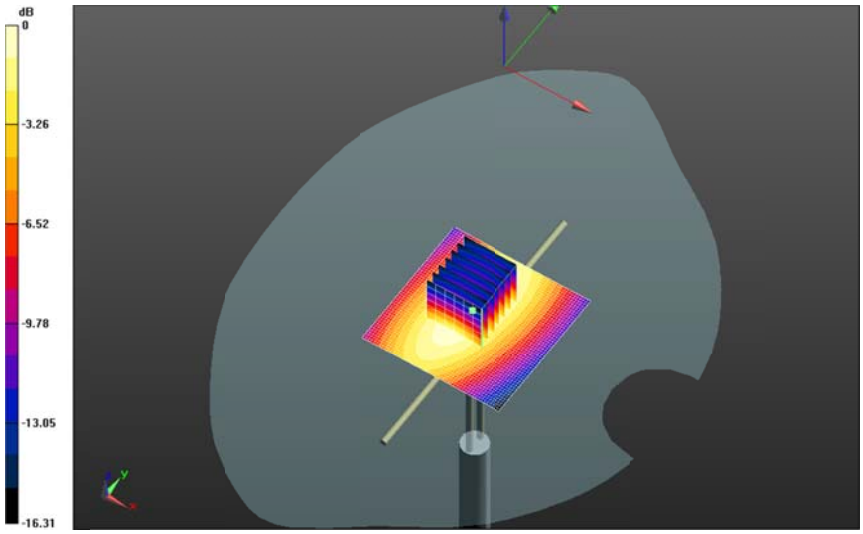
Test Lab: EMCTech Test File: M140907 - 850 MHz 3G -Antenna 1 - wo chip.da52:2

DUT Name: Dipole 900 MHz, Type: DV900V2, Serial: 047

Configuration: System Check
Communication System: 0 - CW; Communication System Band: 900 MHz; Frequency: 900.0 MHz,
Communication System PAR: 0.00 dB; PMF: 0.00; Duty Cycle: 1:1.00
Medium Parameters used: f=900 MHz; σ = 0.94 S/m; ε_r = 39.7; ρ = 1000.0g/cm^3
Phantom section: Flat Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.91,5.91,5.91); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 12; Type: SAM 12; Serial: 1060
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

System Check/Channel 1 Test/Area Scan (51x51x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 2.850 W/kg
System Check/Channel 1 Test/Zoom Scan (31x31x36)/Cube 0: Interpolated grid: dx=1.0 mm, dy=1.0 mm, dz=1.0 mm; Reference Value = 57.409 V/m; **Power Drift = 0.00 dB**
Averaged SAR: SAR(1g) = 2.630 W/kg; SAR(10g) = 1.700 W/kg
Maximum value of SAR (interpolated) = 3.900 W/kg



0 dB = 2.85 W/kg = 4.55 dBW/kg

SAR Measurement Plot 5

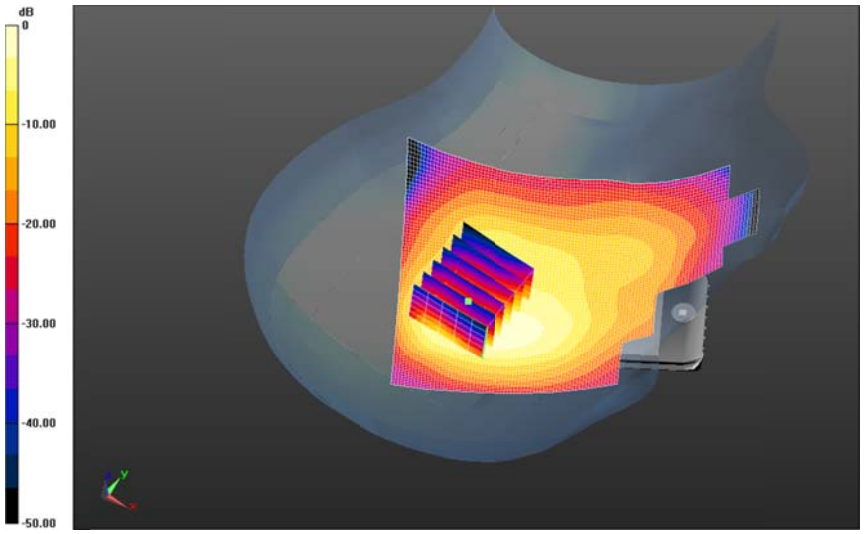
Test Lab: EMCTech Test File: M140907-2100-1900 MHz 3G Antenna 1-w chip-retest.da52:2

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Right 1900 band
Communication System: 0 - WCDMA - UMTS (0); Communication System Band: Band 2 1850 MHz;
Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1880 MHz; σ = 1.37 S/m; ε_r = 40.8; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.04,5.04,5.04); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right 1900 band/Channel 9400 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.893 W/kg
Touch Right 1900 band/Channel 9400 Test/Zoom Scan (26x26x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 6.199 V/m; **Power Drift = -0.18 dB**
Averaged SAR: SAR(1g) = 0.793 W/kg; SAR(10g) = 0.403 W/kg
Maximum value of SAR (interpolated) = 1.630 W/kg



0 dB = 0.893 W/kg = -0.49 dBW/kg

SAR Measurement Plot 6

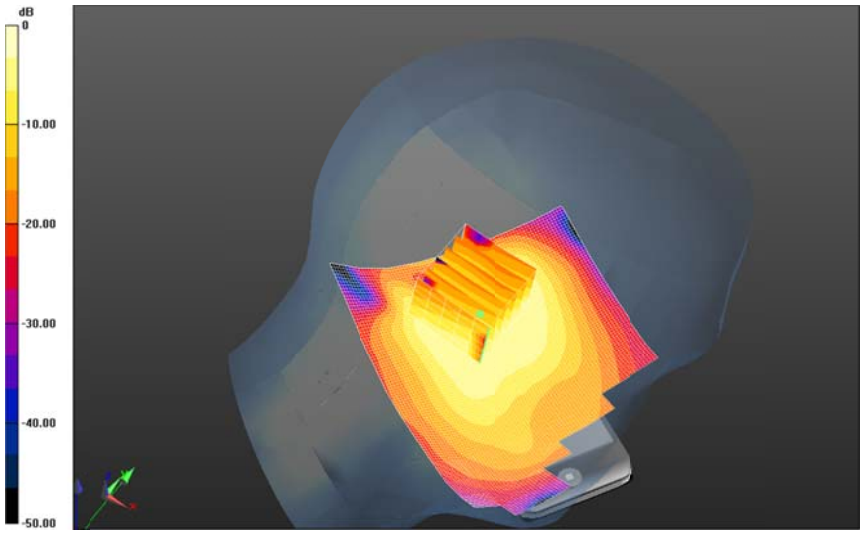
Test Lab: EMCTech Test File: M140907-2100-1900 MHz 3G Antenna 1-w chip-retest.da52:3

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Left 1900 band
Communication System: 0 - WCDMA - UMTS (0); Communication System Band: Band 2 1850 MHz;
Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1880 MHz; σ = 1.37 S/m; ε_r = 40.8; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.04,5.04,5.04); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left 1900 band/Channel 9400 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.727 W/kg
Touch Left 1900 band/Channel 9400 Test/Zoom Scan (26x26x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 5.814 V/m; **Power Drift = -0.02 dB**
Averaged SAR: SAR(1g) = 0.505 W/kg; SAR(10g) = 0.250 W/kg
Maximum value of SAR (interpolated) = 0.989 W/kg



0 dB = 0.727 W/kg = -1.39 dBW/kg

SAR Measurement Plot 7

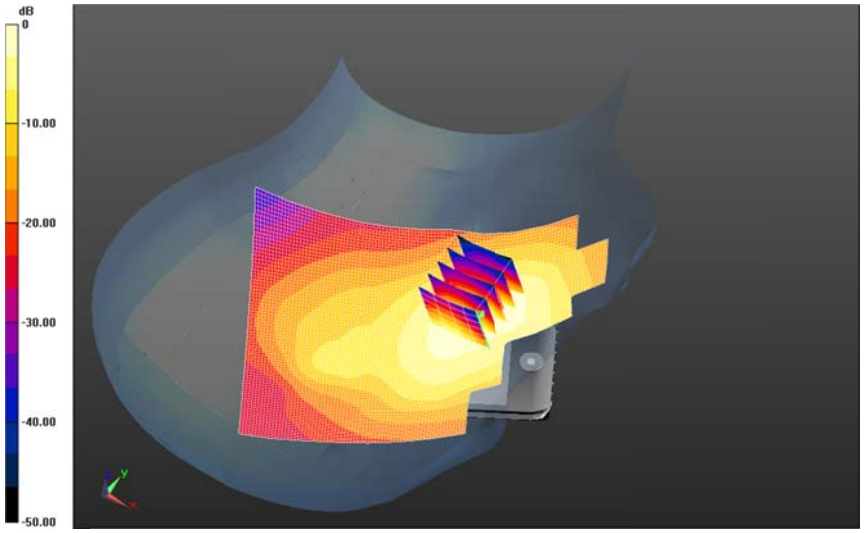
Test Lab: EMCTech Test File: M140907-2100-1900 MHz 3G Antenna 1-wo chip-retest.da52:2

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Right 1900 band
Communication System: 0 - WCDMA - UMTS (0); Communication System Band: Band 2 1850 MHz;
Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1880 MHz; σ = 1.37 S/m; ε_r = 40.8; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.04,5.04,5.04); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right 1900 band/Channel 9400 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 1.350 W/kg
Touch Right 1900 band/Channel 9400 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 28.082 V/m; **Power Drift = -0.17 dB**
Averaged SAR: SAR(1g) = 1.260 W/kg; SAR(10g) = 0.763 W/kg
Maximum value of SAR (interpolated) = 1.830 W/kg



0 dB = 1.35 W/kg = 1.32 dBW/kg

SAR Measurement Plot 8

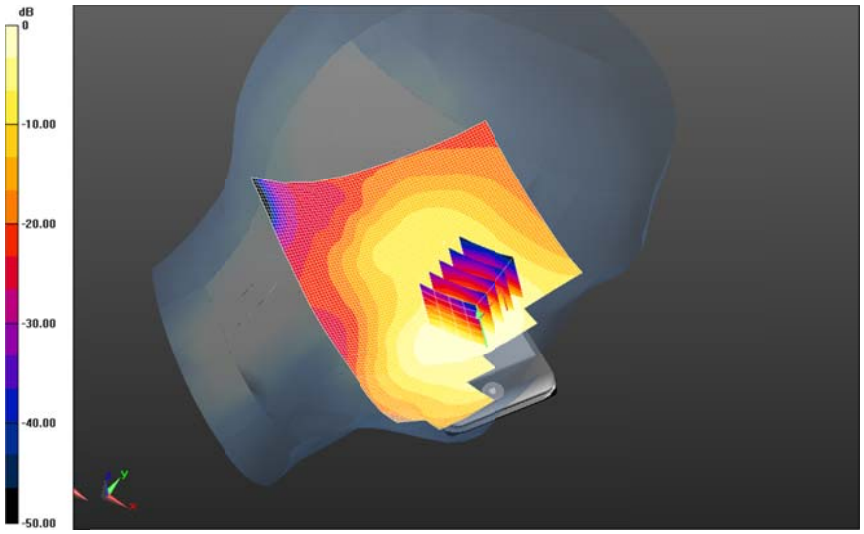
Test Lab: EMCTech Test File: M140907-2100-1900 MHz 3G Antenna 1-wo chip-retest.da52:3

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Left 1900 band
Communication System: 0 - WCDMA - UMTS (0); Communication System Band: Band 2 1850 MHz;
Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1880 MHz; σ = 1.37 S/m; ε_r = 40.8; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.04,5.04,5.04); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left 1900 band/Channel 9400 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.730 W/kg
Touch Left 1900 band/Channel 9400 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 21.663 V/m; **Power Drift = -0.06 dB**
Averaged SAR: SAR(1g) = 0.637 W/kg; SAR(10g) = 0.420 W/kg
Maximum value of SAR (interpolated) = 0.856 W/kg



0 dB = 0.730 W/kg = -1.36 dBW/kg

SAR Measurement Plot 9

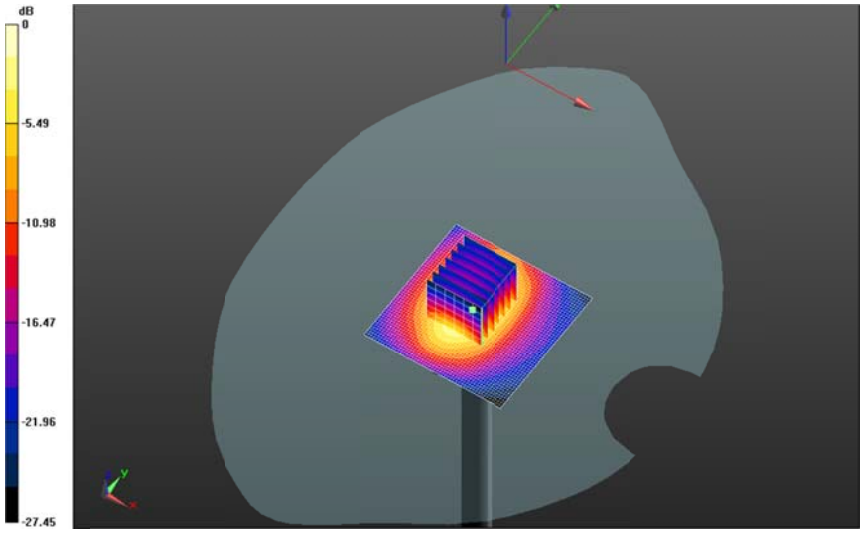
Test Lab: EMCTech Test File: M140907-2100-1900 MHz 3G Antenna 1-w chip-retest.da52:4

DUT Name: Dipole 1950 MHz, Type: DV1950V3, Serial: 1113

Configuration: System Check
Communication System: 0 - CW; Communication System Band: 1950 MHz; Frequency: 1950 MHz,
Communication System PAR: 0.00 dB; PMF: 0.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1950 MHz; σ = 1.42 S/m; ε_r = 40.7; ρ = 1000.0g/cm^3
Phantom section: Flat Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (4.83,4.83,4.83); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

System Check/Channel 1 Test/Area Scan (51x51x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 12.500 W/kg
System Check/Channel 1 Test/Zoom Scan (31x31x36)/Cube 0: Interpolated grid: dx=1.0 mm, dy=1.0 mm, dz=1.0 mm; Reference Value = 94.870 V/m; **Power Drift = 0.05 dB**
Averaged SAR: SAR(1g) = 10.200 W/kg; SAR(10g) = 5.250 W/kg
Maximum value of SAR (interpolated) = 18.200 W/kg



0 dB = 12.5 W/kg = 10.98 dBW/kg

SAR Measurement Plot 10

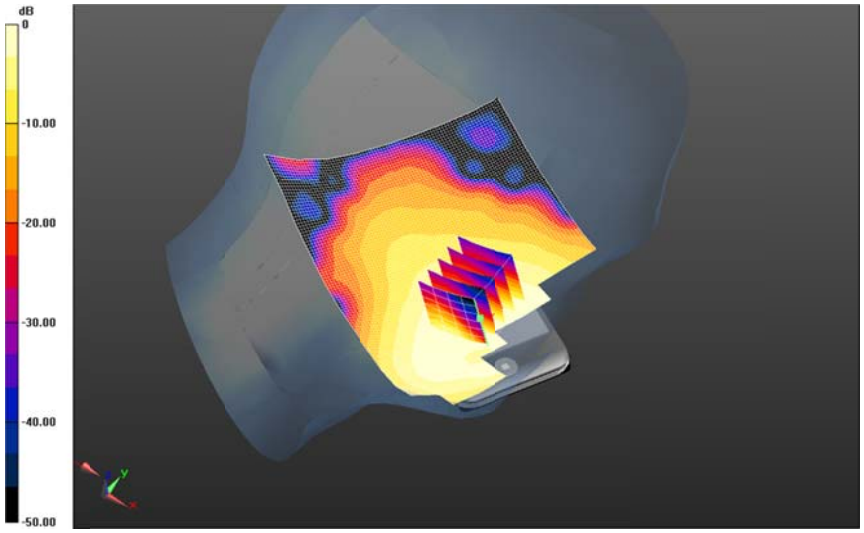
Test Lab: EMCTech Test File: M140907 - 900 MHz 3G -Antenna 1 - w chip.da52:0

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Left
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 8 900 MHz;
Frequency: 897.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=897.5 MHz; σ = 0.94 S/m; ε_r = 39.7; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.91,5.91,5.91); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 12; Type: SAM 12; Serial: 1060
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left/Channel 2788 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.050 W/kg
Touch Left/Channel 2788 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 6.905 V/m; **Power Drift = -0.20 dB**
Averaged SAR: SAR(1g) = 0.050 W/kg; SAR(10g) = 0.035 W/kg
Maximum value of SAR (interpolated) = 0.067 W/kg



0 dB = 0.0496 W/kg = -13.05 dBW/kg

SAR Measurement Plot 11

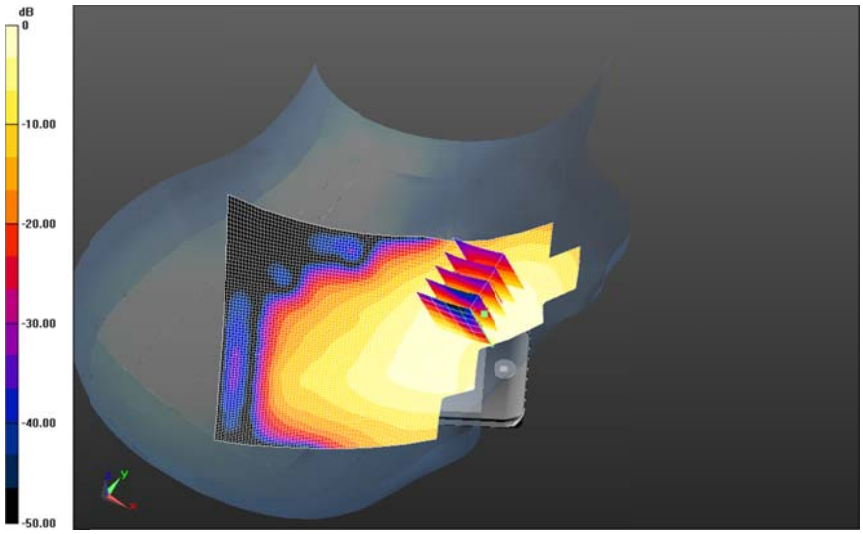
Test Lab: EMCTech Test File: M140907 - 900 MHz 3G -Antenna 1 - w chip.da52:1

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Right
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 8 900 MHz;
Frequency: 897.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=897.5 MHz; σ = 0.94 S/m; ε_r = 39.7; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.91,5.91,5.91); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 12; Type: SAM 12; Serial: 1060
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right/Channel 2788 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.035 W/kg
Touch Right/Channel 2788 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 5.215 V/m; **Power Drift = 0.02 dB**
Averaged SAR: SAR(1g) = 0.034 W/kg; SAR(10g) = 0.022 W/kg
Maximum value of SAR (interpolated) = 0.045 W/kg



0 dB = 0.0349 W/kg = -14.57 dBW/kg

SAR Measurement Plot 12

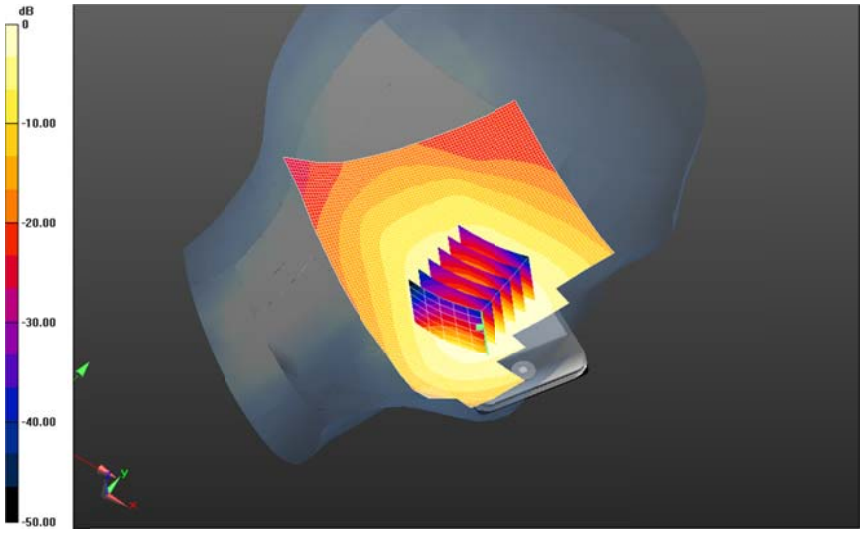
Test Lab: EMCTech Test File: M140907 - 900 MHz 3G -Antenna 1 - wo chip.da52:0

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Left
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 8 900 MHz;
Frequency: 897.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=897.5 MHz; σ = 0.94 S/m; ε_r = 39.7; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.91,5.91,5.91); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 12; Type: SAM 12; Serial: 1060
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left/Channel 2788 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.688 W/kg
Touch Left/Channel 2788 Test/Zoom Scan (26x26x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 28.400 V/m; **Power Drift = -0.15 dB**
Averaged SAR: SAR(1g) = 0.671 W/kg; SAR(10g) = 0.495 W/kg
Maximum value of SAR (interpolated) = 0.775 W/kg



0 dB = 0.688 W/kg = -1.63 dBW/kg

SAR Measurement Plot 13

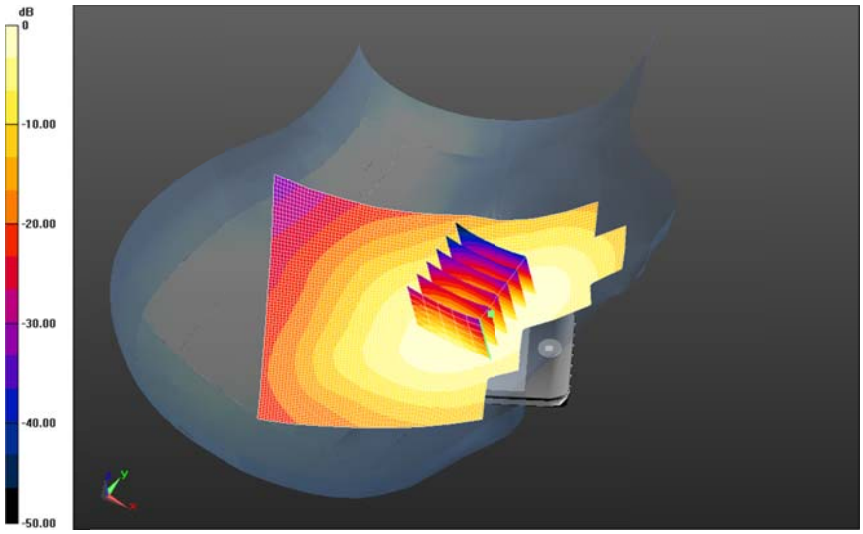
Test Lab: EMCTech Test File: M140907 - 900 MHz 3G -Antenna 1 - wo chip.da52:1

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Right
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 8 900 MHz;
Frequency: 897.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=897.5 MHz; σ = 0.94 S/m; ε_r = 39.7; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.91,5.91,5.91); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 12; Type: SAM 12; Serial: 1060
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right/Channel 2788 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.634 W/kg
Touch Right/Channel 2788 Test/Zoom Scan (26x26x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 8.542 V/m; **Power Drift = 0.20 dB**
Averaged SAR: SAR(1g) = 0.629 W/kg; SAR(10g) = 0.448 W/kg
Maximum value of SAR (interpolated) = 0.819 W/kg



0 dB = 0.634 W/kg = -1.98 dBW/kg

SAR Measurement Plot 14

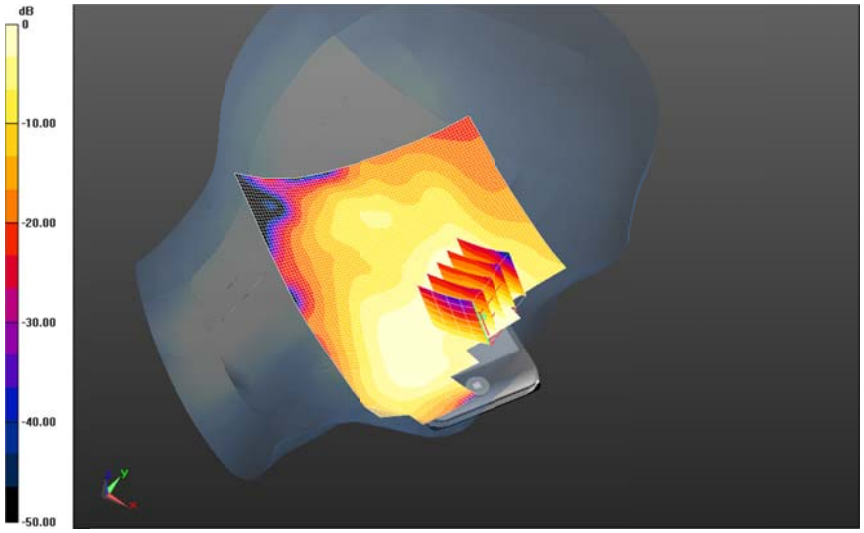
Test Lab: EMCTech Test File: M140907- 2100 MHz 3G Antenna 1-w chip.da52:0

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Left
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 1 2100 MHz;
Frequency: 1950 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1950 MHz; σ = 1.42 S/m; ε_r = 40.7; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (4.83,4.83,4.83); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left/Channel 9750 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.079 W/kg
Touch Left/Channel 9750 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 6.245 V/m; **Power Drift = 0.11 dB**
Averaged SAR: SAR(1g) = 0.075 W/kg; SAR(10g) = 0.046 W/kg
Maximum value of SAR (interpolated) = 0.107 W/kg



0 dB = 0.0792 W/kg = -11.01 dBW/kg

SAR Measurement Plot 15

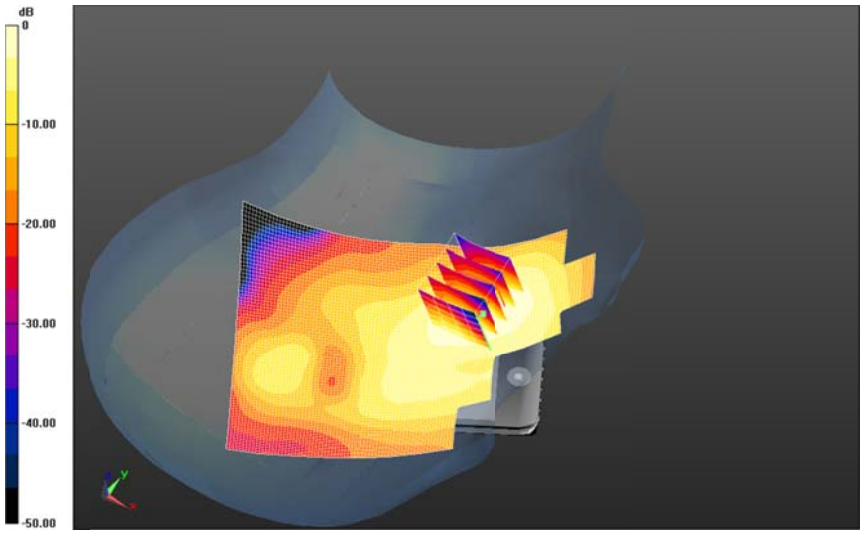
Test Lab: EMCTech Test File: M140907- 2100 MHz 3G Antenna 1-w chip.da52:1

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Right
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 1 2100 MHz;
Frequency: 1950 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1950 MHz; σ = 1.42 S/m; ε_r = 40.7; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (4.83,4.83,4.83); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right/Channel 9750 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.233 W/kg
Touch Right/Channel 9750 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 8.080 V/m; **Power Drift = -0.19 dB**
Averaged SAR: SAR(1g) = 0.212 W/kg; SAR(10g) = 0.122 W/kg
Maximum value of SAR (interpolated) = 0.320 W/kg



0 dB = 0.233 W/kg = -6.32 dBW/kg

SAR Measurement Plot 16

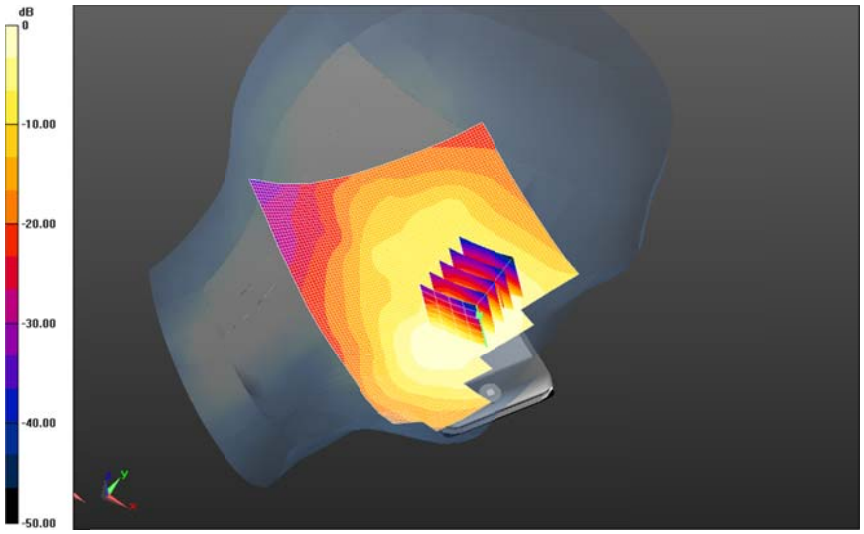
Test Lab: EMCTech Test File: M140907- 2100 MHz 3G Antenna 1-wo chip.da52:0

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Left
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 1 2100 MHz;
Frequency: 1950 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1950 MHz; σ = 1.42 S/m; ε_r = 40.7; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (4.83,4.83,4.83); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left/Channel 9750 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.789 W/kg
Touch Left/Channel 9750 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 22.892 V/m; **Power Drift = 0.12 dB**
Averaged SAR: SAR(1g) = 0.720 W/kg; SAR(10g) = 0.472 W/kg
Maximum value of SAR (interpolated) = 0.991 W/kg



0 dB = 0.789 W/kg = -1.03 dBW/kg

SAR Measurement Plot 17

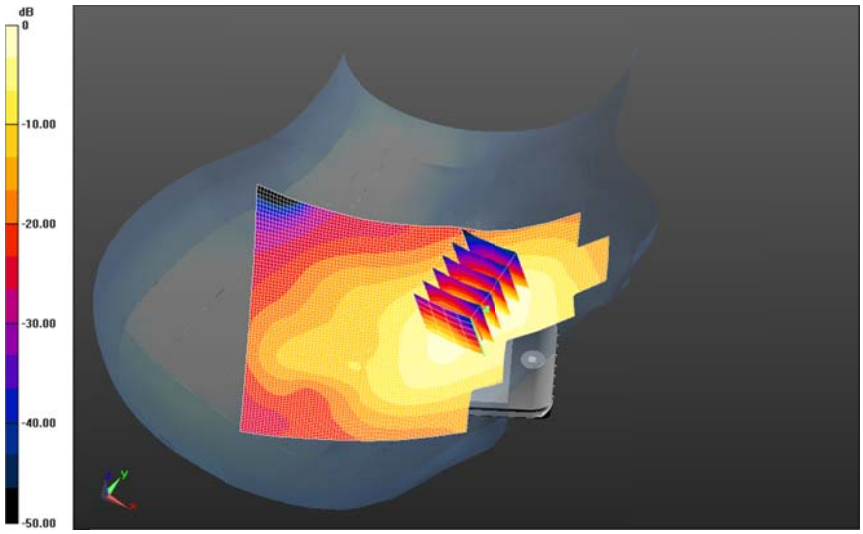
Test Lab: EMCTech Test File: M140907- 2100 MHz 3G Antenna 1-wo chip.da52:1

DUT Name: Apple GSM-3G Mobile Phone, Type: iPhone 5, Serial: IMEI: 013552006298512

Configuration: Touch Right
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 1 2100 MHz;
Frequency: 1950 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1950 MHz; σ = 1.42 S/m; ε_r = 40.7; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (4.83,4.83,4.83); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right/Channel 9750 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 1.400 W/kg
Touch Right/Channel 9750 Test/Zoom Scan (21x26x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 26.798 V/m; **Power Drift = 0.07 dB**
Averaged SAR: SAR(1g) = 1.300 W/kg; SAR(10g) = 0.775 W/kg
Maximum value of SAR (interpolated) = 1.960 W/kg



0 dB = 1.40 W/kg = 1.45 dBW/kg

SAR Measurement Plot 18

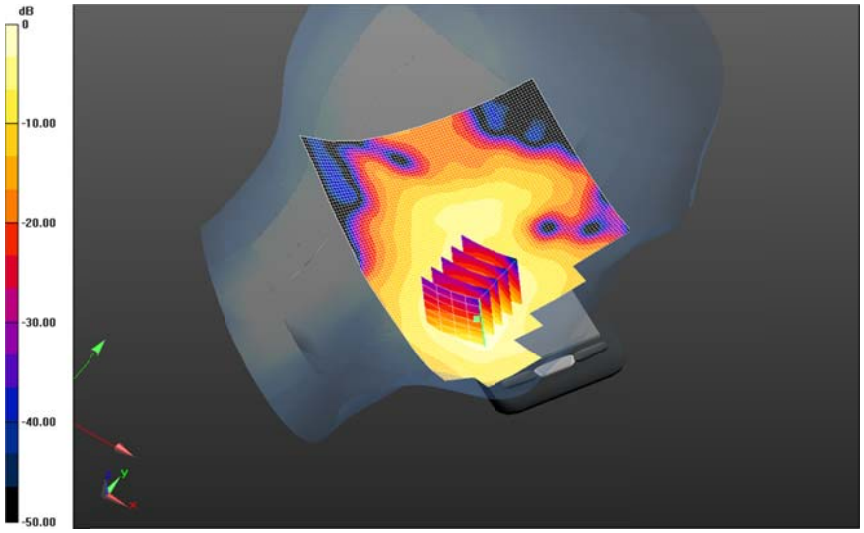
Test Lab: EMCTech Test File: M140907 2100-1900 3G w chip.da52:0

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Left
Communication System: 0 - WCDMA - UMTS (0); Communication System Band: Band 2 1850 MHz;
Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1880 MHz; σ = 1.37 S/m; ε_r = 40.8; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.04,5.04,5.04); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left/Channel 9400 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.055 W/kg
Touch Left/Channel 9400 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 5.137 V/m; **Power Drift = -0.13 dB**
Averaged SAR: SAR(1g) = 0.054 W/kg; SAR(10g) = 0.031 W/kg
Maximum value of SAR (interpolated) = 0.087 W/kg



0 dB = 0.0550 W/kg = -12.59 dBW/kg

SAR Measurement Plot 19

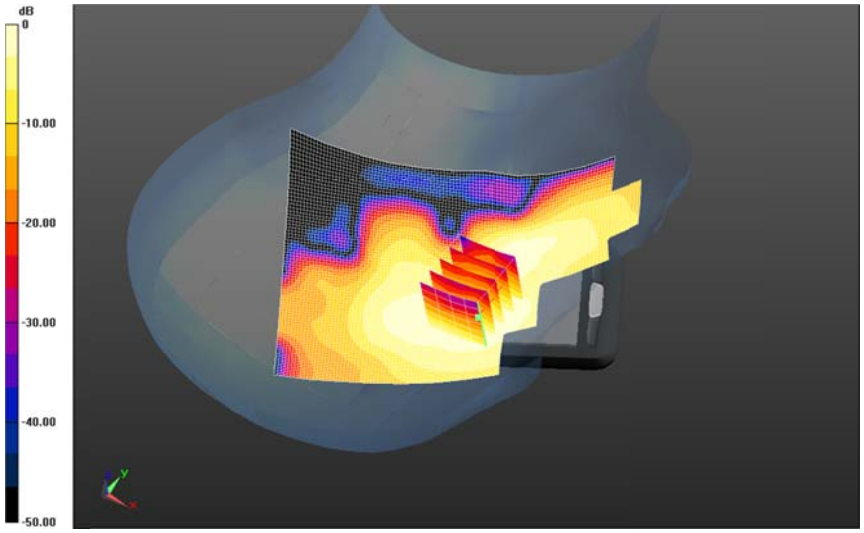
Test Lab: EMCTech Test File: M140907 2100-1900 3G w chip.da52:1

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Right
Communication System: 0 - WCDMA - UMTS (0); Communication System Band: Band 2 1850 MHz;
Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1880 MHz; σ = 1.37 S/m; ε_r = 40.8; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.04,5.04,5.04); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right/Channel 9400 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.034 W/kg
Touch Right/Channel 9400 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 3.932 V/m; **Power Drift = 0.18 dB**
Averaged SAR: SAR(1g) = 0.032 W/kg; SAR(10g) = 0.019 W/kg
Maximum value of SAR (interpolated) = 0.050 W/kg



0 dB = 0.0343 W/kg = -14.64 dBW/kg

SAR Measurement Plot 20

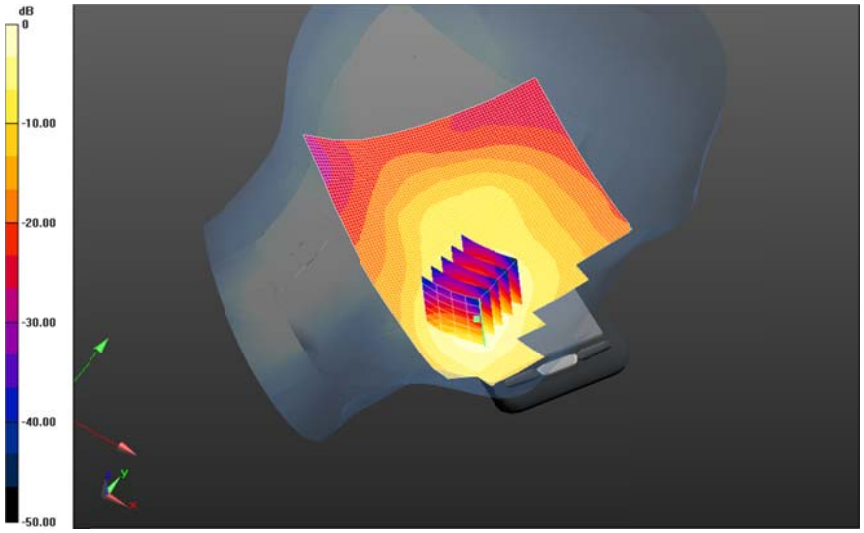
Test Lab: EMCTech Test File: M140907 2100-1900 3G wo chip.da52:0

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Left
Communication System: 0 - WCDMA - UMTS (0); Communication System Band: Band 2 1850 MHz;
Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1880 MHz; σ = 1.37 S/m; ε_r = 40.8; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.04,5.04,5.04); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left/Channel 9400 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.574 W/kg
Touch Left/Channel 9400 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 16.326 V/m; **Power Drift = -0.10 dB**
Averaged SAR: SAR(1g) = 0.506 W/kg; SAR(10g) = 0.306 W/kg
Maximum value of SAR (interpolated) = 0.758 W/kg



0 dB = 0.574 W/kg = -2.41 dBW/kg

SAR Measurement Plot 21

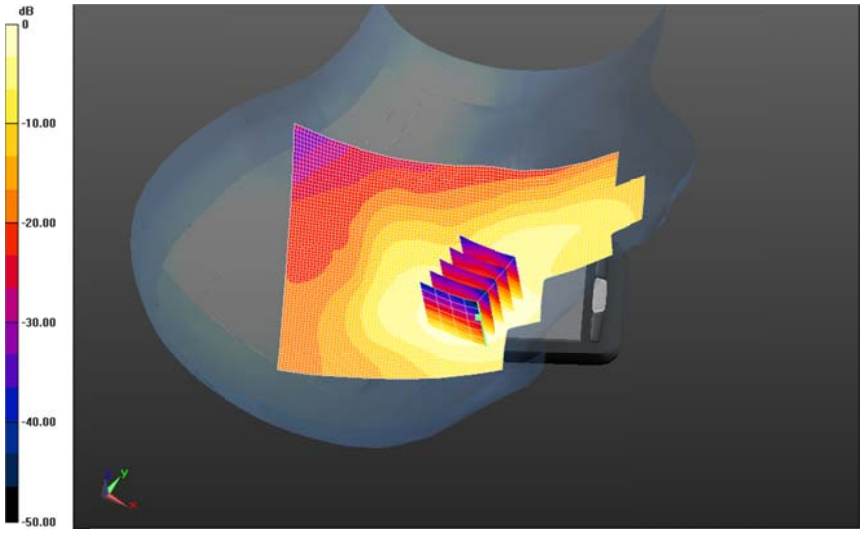
Test Lab: EMCTech Test File: M140907 2100-1900 3G wo chip.da52:1

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Right
Communication System: 0 - WCDMA - UMTS (0); Communication System Band: Band 2 1850 MHz;
Frequency: 1880 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1880 MHz; σ = 1.37 S/m; ε_r = 40.8; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.04,5.04,5.04); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right/Channel 9400 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.303 W/kg
Touch Right/Channel 9400 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 11.126 V/m; **Power Drift = 0.09 dB**
Averaged SAR: SAR(1g) = 0.283 W/kg; SAR(10g) = 0.176 W/kg
Maximum value of SAR (interpolated) = 0.407 W/kg



0 dB = 0.303 W/kg = -5.19 dBW/kg

SAR Measurement Plot 22

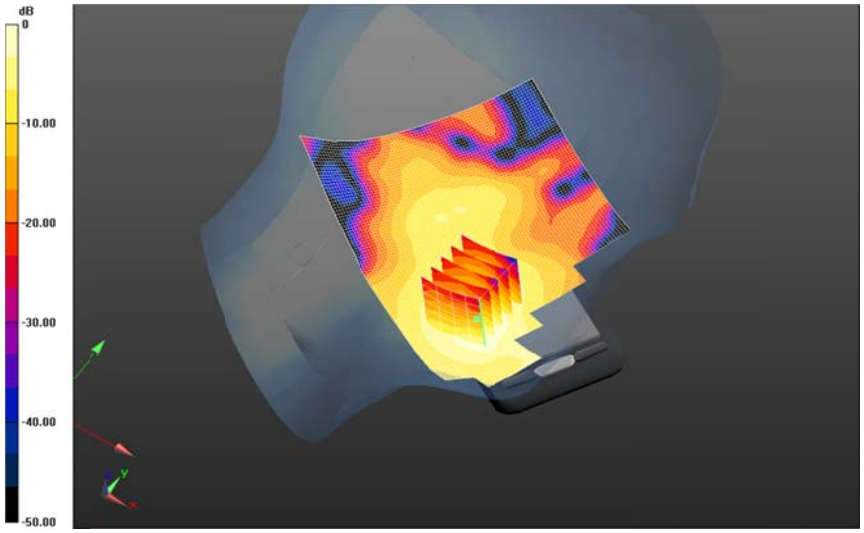
Test Lab: EMCTech Test File: M140907 2100-1900 3G w chip.da52:0

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Left
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 1 2100 MHz;
Frequency: 1950 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1950 MHz; σ = 1.42 S/m; ε_r = 40.7; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (4.83,4.83,4.83); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left/Channel 9750 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.047 W/kg
Touch Left/Channel 9750 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 4.229 V/m; **Power Drift = -0.04 dB**
Averaged SAR: SAR(1g) = 0.044 W/kg; SAR(10g) = 0.025 W/kg
Maximum value of SAR (interpolated) = 0.071 W/kg



0 dB = 0.0468 W/kg = -13.29 dBW/kg

SAR Measurement Plot 23

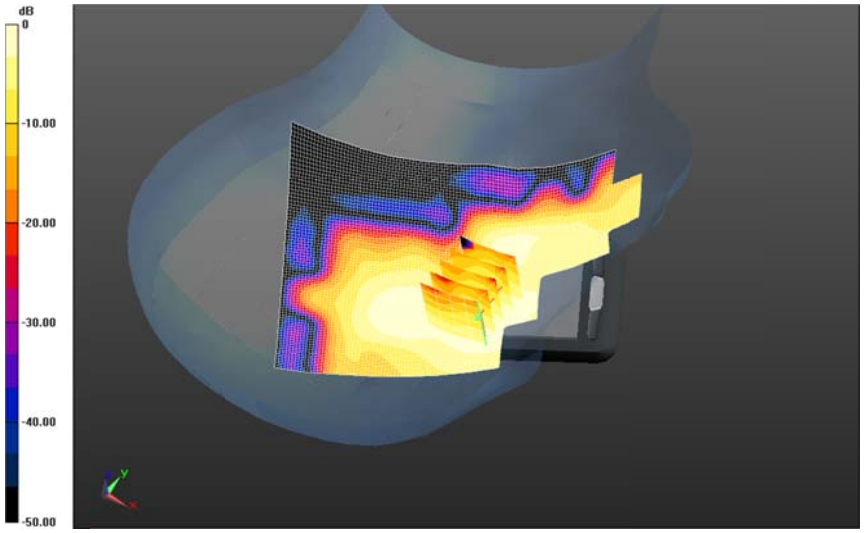
Test Lab: EMCTech Test File: M140907 2100-1900 3G w chip.da52:1

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Right
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 1 2100 MHz;
Frequency: 1950 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1950 MHz; σ = 1.42 S/m; ε_r = 40.7; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (4.83,4.83,4.83); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right/Channel 9750 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.019 W/kg
Touch Right/Channel 9750 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 2.778 V/m; **Power Drift = 0.07 dB**
Averaged SAR: SAR(1g) = 0.020 W/kg; SAR(10g) = 0.011 W/kg
Maximum value of SAR (interpolated) = 0.032 W/kg



0 dB = 0.0192 W/kg = -17.16 dBW/kg

SAR Measurement Plot 24

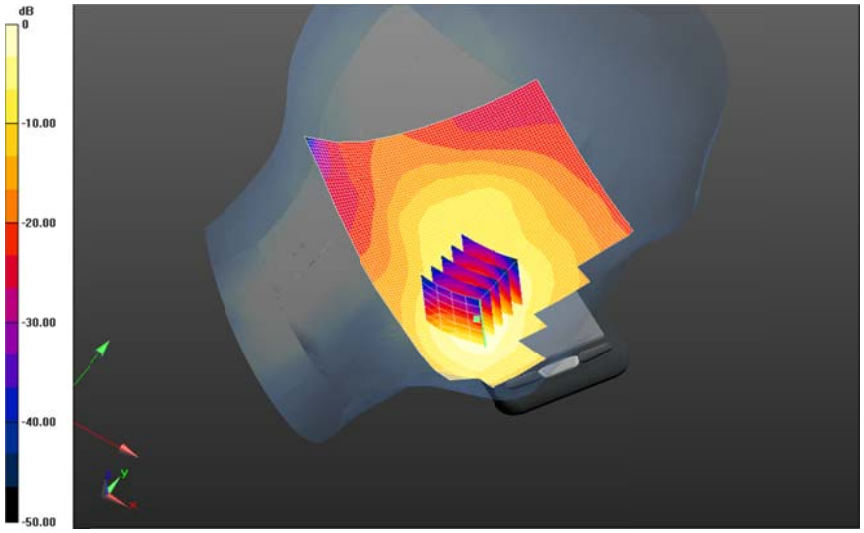
Test Lab: EMCTech Test File: M140907 2100-1900 3G wo chip.da52:0

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Left
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 1 2100 MHz;
Frequency: 1950 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1950 MHz; σ = 1.42 S/m; ε_r = 40.7; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (4.83,4.83,4.83); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left/Channel 9750 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.608 W/kg
Touch Left/Channel 9750 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 16.367 V/m; **Power Drift = 0.14 dB**
Averaged SAR: SAR(1g) = 0.541 W/kg; SAR(10g) = 0.322 W/kg
Maximum value of SAR (interpolated) = 0.835 W/kg



0 dB = 0.608 W/kg = -2.16 dBW/kg

SAR Measurement Plot 25

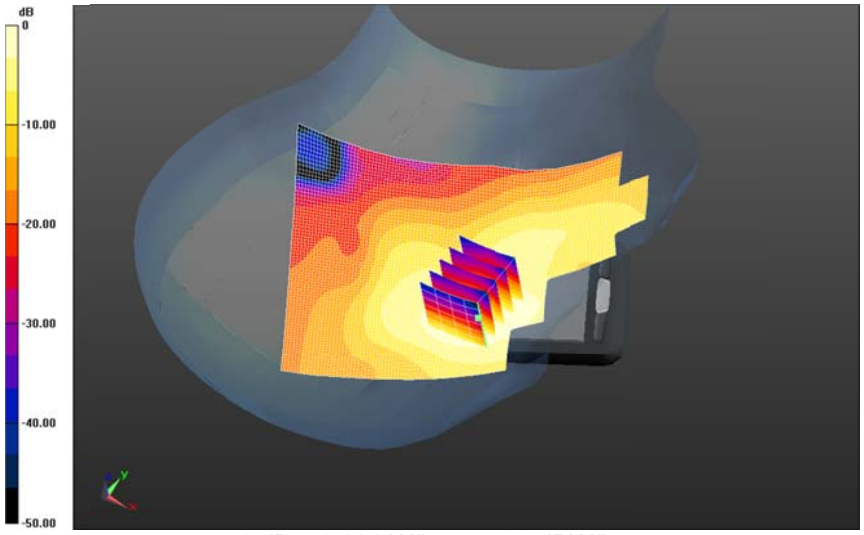
Test Lab: EMCTech Test File: M140907 2100-1900 3G wo chip.da52:1

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Right
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 1 2100 MHz;
Frequency: 1950 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1950 MHz; σ = 1.42 S/m; ε_r = 40.7; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (4.83,4.83,4.83); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right/Channel 9750 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.291 W/kg
Touch Right/Channel 9750 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 10.586 V/m; **Power Drift = -0.05 dB**
Averaged SAR: SAR(1g) = 0.265 W/kg; SAR(10g) = 0.162 W/kg
Maximum value of SAR (interpolated) = 0.385 W/kg



0 dB = 0.291 W/kg = -5.36 dBW/kg

SAR Measurement Plot 26

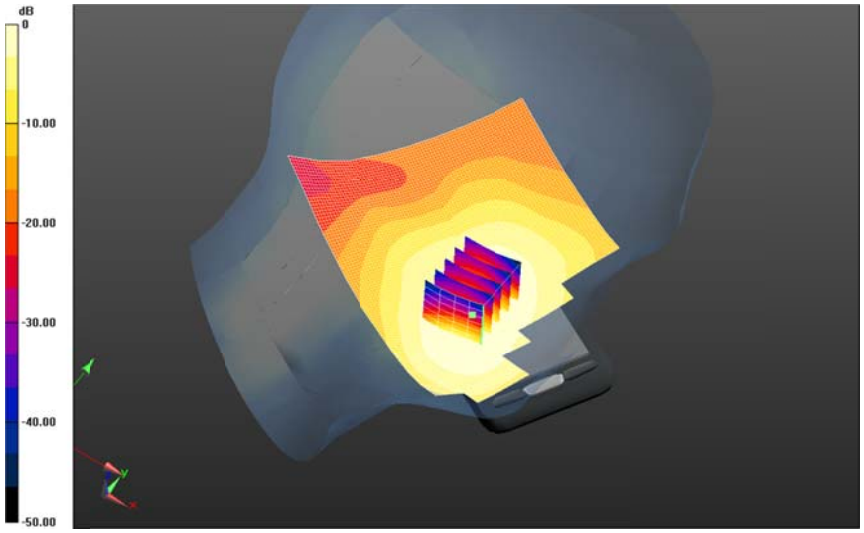
Test Lab: EMCTech Test File: M140907 - 900 MHz 3G-retest-19-9-with chip.da52:0

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Left-with chip
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 8 900 MHz;
Frequency: 897.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=900 MHz; σ = 0.97 S/m; ε_r = 41.5; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.91,5.91,5.91); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 12; Type: SAM 12; Serial: 1060
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left-with chip/Channel 2788 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.292 W/kg
Touch Left-with chip/Channel 2788 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 17.966 V/m; **Power Drift = -0.01 dB**
Averaged SAR: SAR(1g) = 0.302 W/kg; SAR(10g) = 0.219 W/kg
Maximum value of SAR (interpolated) = 0.371 W/kg



0 dB = 0.292 W/kg = -5.34 dBW/kg

SAR Measurement Plot 27

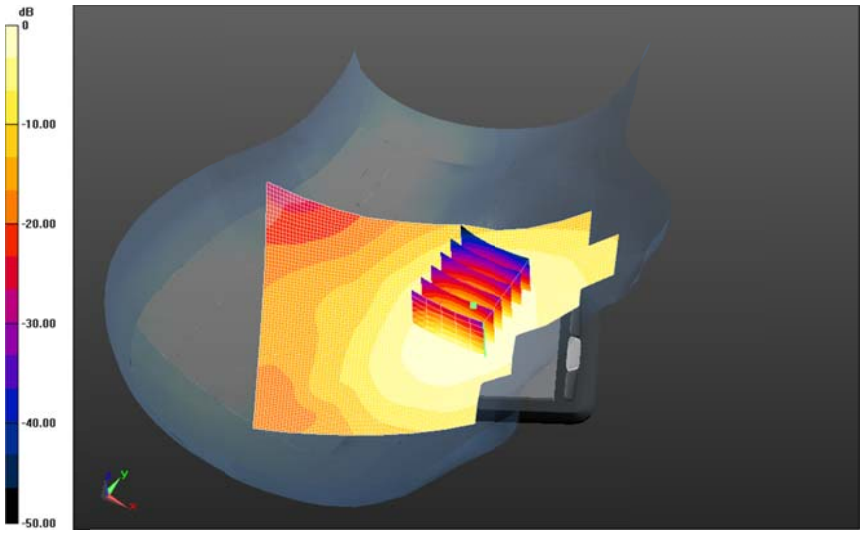
Test Lab: EMCTech Test File: M140907 - 900 MHz 3G-retest-19-9-with chip.da52:1

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Right-with chip
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 8 900 MHz;
Frequency: 897.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=900 MHz; σ = 0.97 S/m; ε_r = 41.5; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.91,5.91,5.91); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 12; Type: SAM 12; Serial: 1060
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right-with chip/Channel 2788 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.255 W/kg
Touch Right-with chip/Channel 2788 Test/Zoom Scan (26x26x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 16.546 V/m; **Power Drift = -0.05 dB**
Averaged SAR: SAR(1g) = 0.252 W/kg; SAR(10g) = 0.188 W/kg
Maximum value of SAR (interpolated) = 0.307 W/kg



0 dB = 0.255 W/kg = -5.94 dBW/kg

SAR Measurement Plot 28

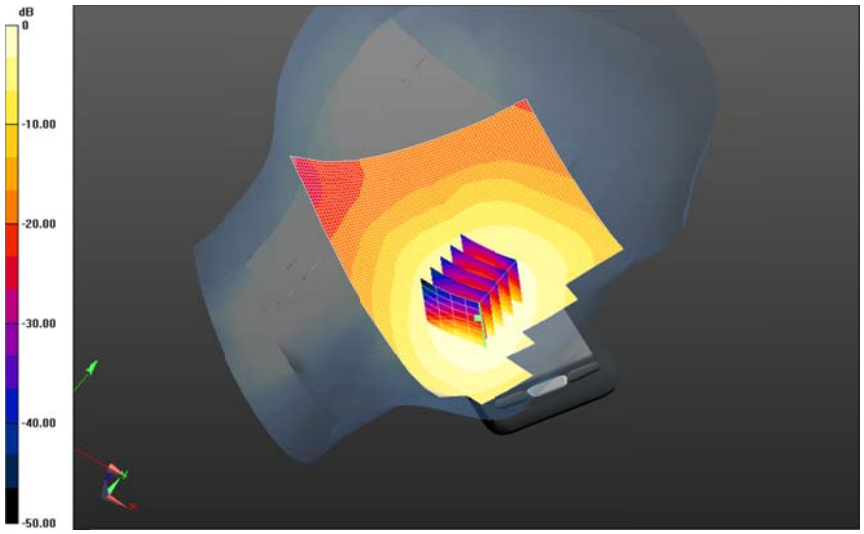
Test Lab: The name of your organization Test File: M140907 - 900 MHz 3G-retest without chip.da52:2

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Left-without chip
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 8 900 MHz;
Frequency: 897.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=900 MHz; σ = 0.97 S/m; ε_r = 41.5; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.91,5.91,5.91); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 12; Type: SAM 12; Serial: 1060
DASY52 52.8.7(1137); SEMCAD X Version 14.6.10 (7331)

Touch Left-without chip/Channel 2788 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.582 W/kg
Touch Left-without chip/Channel 2788 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 24.513 V/m; **Power Drift = 0.06 dB**
Averaged SAR: SAR(1g) = 0.580 W/kg; SAR(10g) = 0.411 W/kg
Maximum value of SAR (interpolated) = 0.783 W/kg



0 dB = 0.582 W/kg = -2.35 dBW/kg

SAR Measurement Plot 29

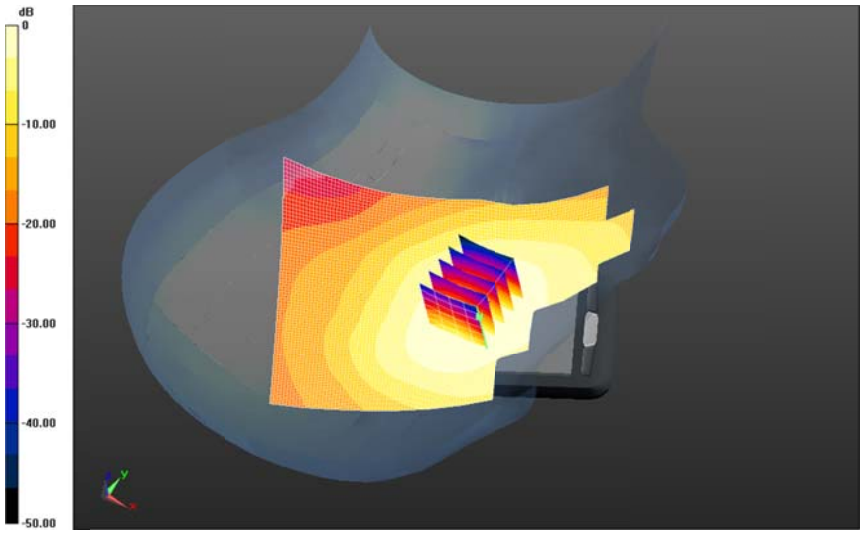
Test Lab: The name of your organization Test File: M140907 - 900 MHz 3G-retest without chip.da52:3

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Right-without chip
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 8 900 MHz;
Frequency: 897.6 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=900 MHz; σ = 0.97 S/m; ε_r = 41.5; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (5.91,5.91,5.91); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 12; Type: SAM 12; Serial: 1060
DASY52 52.8.7(1137); SEMCAD X Version 14.6.10 (7331)

Touch Right-without chip/Channel 2788 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm; Maximum value of SAR (interpolated) = 0.423 W/kg
Touch Right-without chip/Channel 2788 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 21.637 V/m; **Power Drift = 0.02 dB**
Averaged SAR: SAR(1g) = 0.422 W/kg; SAR(10g) = 0.321 W/kg
Maximum value of SAR (interpolated) = 0.496 W/kg



0 dB = 0.423 W/kg = -3.74 dBW/kg

SAR Measurement Plot 30

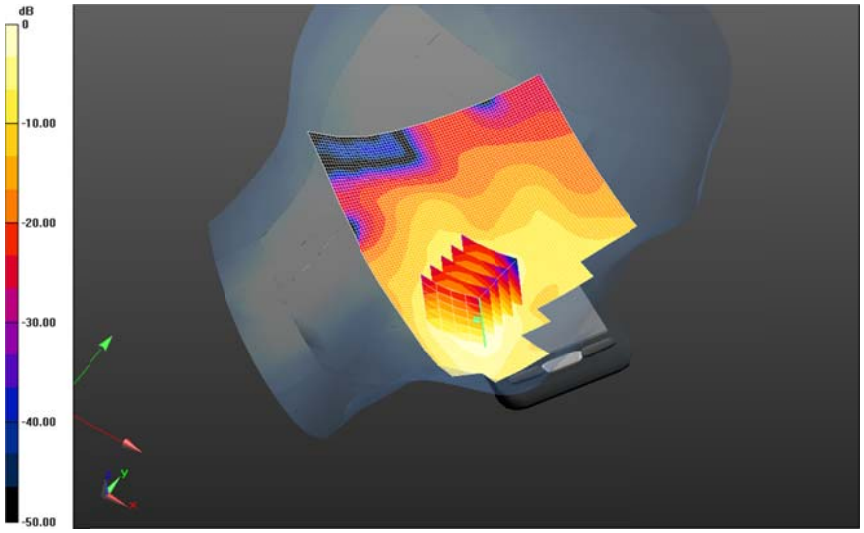
Test Lab: EMCTech Test File: M140907 Phone 2100 MHz 3G w chip.da52:0

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Left
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 1 2100 MHz;
Frequency: 1950 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1950 MHz; σ = 1.42 S/m; ε_r = 40.7; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (4.83,4.83,4.83); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left/Channel 9750 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.132 W/kg
Touch Left/Channel 9750 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 6.266 V/m; **Power Drift = 0.16 dB**
Averaged SAR: SAR(1g) = 0.115 W/kg; SAR(10g) = 0.068 W/kg
Maximum value of SAR (interpolated) = 0.182 W/kg



0 dB = 0.132 W/kg = -8.79 dBW/kg

SAR Measurement Plot 31

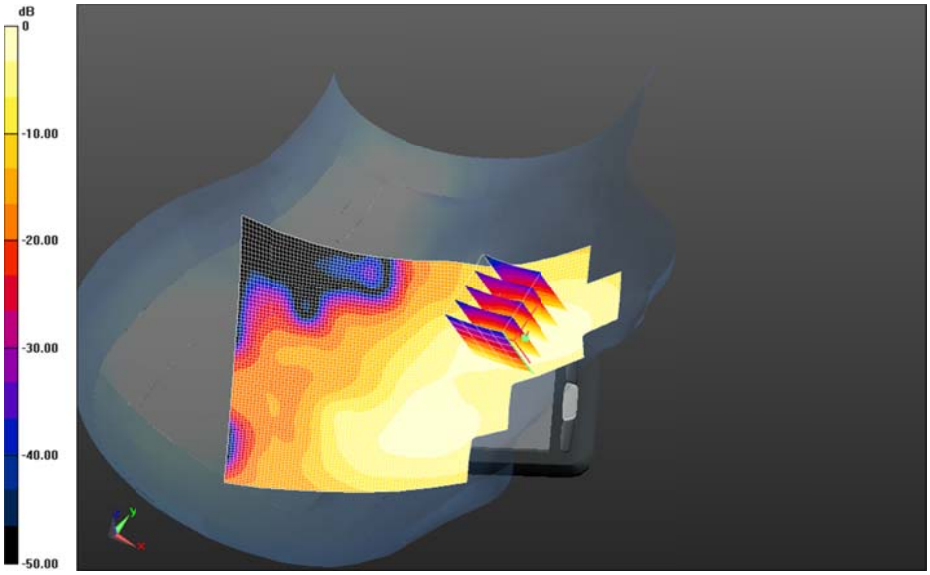
Test Lab: EMCTech Test File: M140907 Phone 2100 MHz 3G w chip.da52:1

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Right
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 1 2100 MHz;
Frequency: 1950 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1950 MHz; σ = 1.42 S/m; ε_r = 40.7; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (4.83,4.83,4.83); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right/Channel 9750 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.074 W/kg
Touch Right/Channel 9750 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 5.206 V/m; **Power Drift = 0.18 dB**
Averaged SAR: SAR(1g) = 0.065 W/kg; SAR(10g) = 0.040 W/kg
Maximum value of SAR (interpolated) = 0.099 W/kg



0 dB = 0.0742 W/kg = -11.30 dBW/kg

SAR Measurement Plot 32

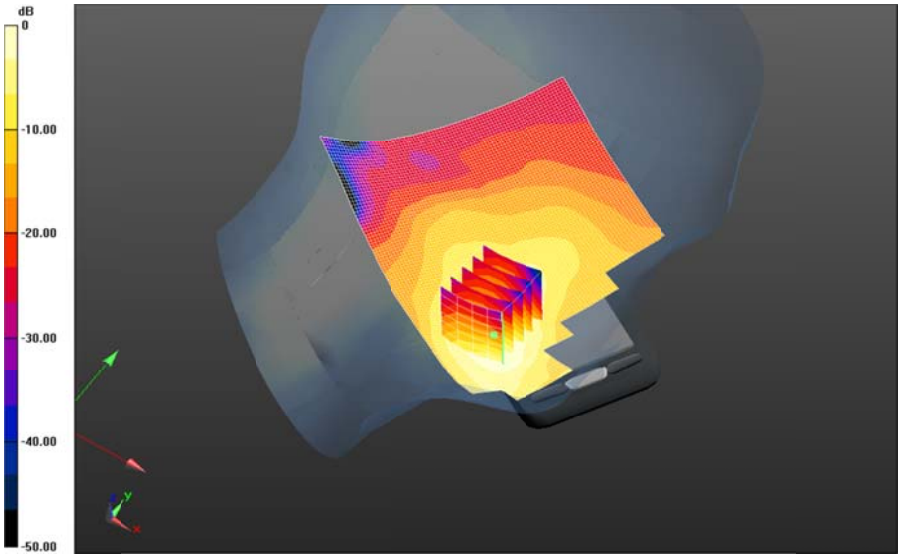
Test Lab: EMCTech Test File: M140907 Phone 2100 MHz 3G wo chip.da52:0

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Left
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 1 2100 MHz;
Frequency: 1950 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1950 MHz; σ = 1.42 S/m; ε_r = 40.7; ρ = 1000.0g/cm^3
Phantom section: Left Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (4.83,4.83,4.83); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Left/Channel 9750 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.524 W/kg
Touch Left/Channel 9750 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 12.429 V/m; **Power Drift = -0.04 dB**
Averaged SAR: SAR(1g) = 0.449 W/kg; SAR(10g) = 0.264 W/kg
Maximum value of SAR (interpolated) = 0.699 W/kg



0 dB = 0.524 W/kg = -2.81 dBW/kg

SAR Measurement Plot 33

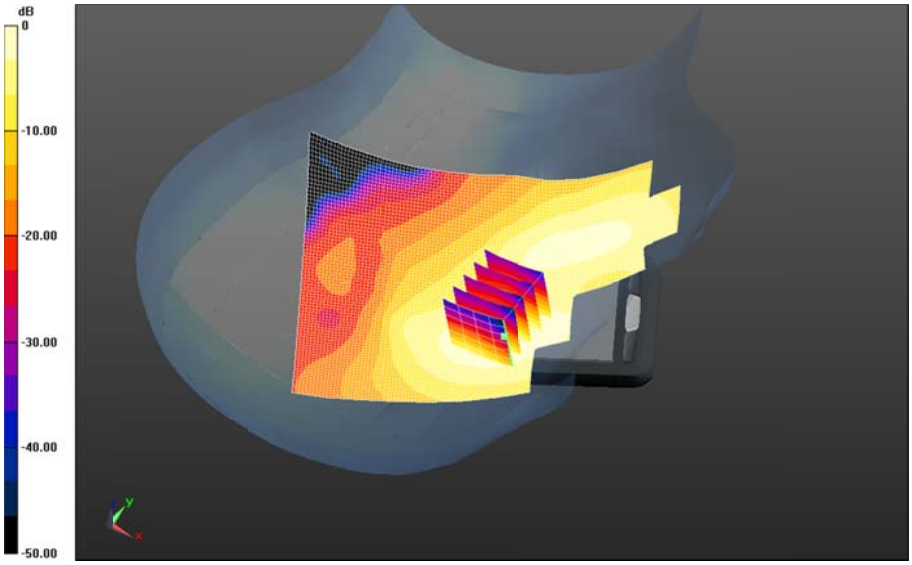
Test Lab: EMCTech Test File: M140907 Phone 2100 MHz 3G wo chip.da52:1

DUT Name: Samsung GSM-3G Mobile Phone, Type: GT-S7710, Serial: R31D20TJ68J

Configuration: Touch Right
Communication System: 0 - WCDMA - UMTS; Communication System Band: Band 1 2100 MHz;
Frequency: 1950 MHz, Communication System PAR: 0.00 dB; PMF: 1.00; Duty Cycle: 1:1.00
Medium Parameters used: f=1950 MHz; σ = 1.42 S/m; ε_r = 40.7; ρ = 1000.0g/cm^3
Phantom section: Right Section

DASY Configuration:
Probe: ET3DV6 - SN1380; ConvF: (4.83,4.83,4.83); Calibrated: 13/12/2013;
Sensor-Surface: 4 mm (Mechanical Surface Detection)
Electronics: DAE3 Sn442; Calibrated: 10/12/2013
Phantom: SAM 22; Type: SAM 22; Serial: 1260
DASY52 52.8.8(1222); SEMCAD X Version 14.6.10 (7331)

Touch Right/Channel 9750 Test/Area Scan (141x81x1): Interpolated grid: dx=1.5 mm, dy=1.5 mm;
Maximum value of SAR (interpolated) = 0.249 W/kg
Touch Right/Channel 9750 Test/Zoom Scan (21x21x36)/Cube 0: Interpolated grid: dx=1.6 mm, dy=1.6 mm, dz=1.0 mm; Reference Value = 10.095 V/m; **Power Drift = 0.04 dB**
Averaged SAR: SAR(1g) = 0.231 W/kg; SAR(10g) = 0.143 W/kg
Maximum value of SAR (interpolated) = 0.340 W/kg



0 dB = 0.249 W/kg = -6.04 dBW/kg

SAR Measurement Plot 34

APPENDIX C DESCRIPTION OF SAR MEASUREMENT SYSTEM

Probe Positioning System

The measurements were performed with the state of the art automated near-field scanning system **DASY5 Version 52** from Schmid & Partner Engineering AG (SPEAG). The system is based on a high precision 6-axis robot (working range greater than 1.1m), which positions the SAR measurement probes with a positional repeatability of better than ±0.02 mm. The DASY5 fully complies with the IEEE 1528 and EN62209 SAR measurement requirements.

E-Field Probe Type and Performance

The SAR measurements were conducted with the dosimetric probe ET3DV6 or EX3DV4 was used (manufactured by SPEAG). The SAR probes are designed in the classical triangular configuration and optimised for dosimetric evaluation. The probe has been calibrated and found to be accurate to better than ±0.25 dB. The probe is suitable for measurements close to material discontinuity at the surface of the phantom.

Data Acquisition Electronics

The data acquisition electronics (DAE3) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. The input impedance of the DAE3 box is 200 MΩ; the inputs are symmetrical and floating. Common mode rejection is above 80dB.Transmission to the PC-card is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.

The mechanical probe-mounting device includes two different sensor systems for frontal and sideways probe contacts. They are used for mechanical surface detection and probe collision detection.

Device Holder for DASY5

The DASY5 device holder supplied by SPEAG is designed to cope with different positions given in the standard. It has two scales for the device rotation (with respect to the body axis) and the device inclination (with respect to the line between the ear openings). The rotation centres for both scales is the ear opening. Thus the device needs no repositioning when changing the angles.

The DASY5 device holder is made of low-loss material having the following dielectric parameters: relative permittivity ε=3 and loss tangent δ=0.02. The amount of dielectric material has been reduced in the closest vicinity of the device, to reduce the influence on the clamp on the test results.

Refer to Appendix A for photograph of device positioning.

Liquid Depth 15cm

During the SAR measurement process the liquid level was maintained to a level of a least 15cm with a tolerance of ± 0.5cm.

Phantom Properties (Size, Shape, Shell Thickness, Tissue Material Properties)

The phantom used during the SAR testing and validation was the “SAM” phantom from SPEAG. The phantom thickness is 2.0mm+/-0.2 mm and was filled with the required tissue simulating liquid.

The dielectric parameters of the simulating liquid were measured prior to SAR assessment using the HP85070A dielectric probe kit and HP8753ES Network Analyser. The target dielectric parameters are shown in the following table.

Table: Target Simulating Liquid Dielectric Values UMTS Bands

	Frequency (MHz)	∈r (target)	σ (target)	ρ kg/m^3
Band	**UMTS Band 1**			
Frequency (MHz)	1922.4	40.0 ±5% (38.0 to 42.0)	1.40 ±5% (1.33 to 1.47)	1000
	1950	40.0 ±5% (38.0 to 42.0)	1.40 ±5% (1.33 to 1.47)	1000
	1977.6	40.0 ±5% (38.0 to 42.0)	1.40 ±5% (1.33 to 1.47)	1000
Band	**UMTS Band 2**			
Frequency (MHz)	1852.4	40.0 ±5% (38.0 to 42.0)	1.40 ±5% (1.33 to 1.47)	1000
	1880	40.0 ±5% (38.0 to 42.0)	1.40 ±5% (1.33 to 1.47)	1000
	1907.6	40.0 ±5% (38.0 to 42.0)	1.40 ±5% (1.33 to 1.47)	1000
Band	**UMTS Band 5**			
Frequency (MHz)	826.4	41.5 ±5% (39.4 to 43.6)	0.90 ±5% (0.86 to 0.95)	1000
	836.6	41.5 ±5% (39.4 to 43.6)	0.90 ±5% (0.86 to 0.95)	1000
	846.6	41.5 ±5% (39.4 to 43.6)	0.90 ±5% (0.86 to 0.95)	1000
Band	**UMTS Band 8**			
Frequency (MHz)	882.4	41.5 ±5% (39.4 to 43.6)	0.97 ±5% (0.92 to 1.02)	1000
	897.6	41.5 ±5% (39.4 to 43.6)	0.97 ±5% (0.92 to 1.02)	1000
	912.6	41.5 ±5% (39.4 to 43.6)	0.97 ±5% (0.92 to 1.02)	1000

Note: The liquid parameters were within the required tolerances of ±5%.

Simulated Tissue Composition Used for SAR Test

The tissue simulating liquids are created prior to the SAR evaluation and often require slight modification each day to obtain the correct dielectric parameters.

Table: Tissue Type: @ 850/900MHz
Volume of Liquid: 30 Litres

Approximate Composition	% By Weight
Distilled Water	41.05
Salt	1.35
Sugar	56.5
HEC	1.0
Bactericide	0.1

Table: Tissue Type: @ 1800/1950MHz
Volume of Liquid: 30 Litres

Approximate Composition	% By Weight
Distilled Water	61.17
Salt	0.31
Bactericide	0.29
Triton X-100	38.23

APPENDIX D CALIBRATION DOCUMENTS

1. ET3DV6 SN: 1380 Probe Calibration Certificate
2. SN: 047 D900V2 Dipole Calibration Certificate
3. SN: 1113 D1950V3 Dipole Calibration Certificate
4. SN: 442 DAE3 Data Acquisition Electronics Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

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Accreditation No.: SCS 108

Client EMC Technologies

Certificate No: ET3-1380_Dec13

CALIBRATION CERTIFICATE

Object: ET3DV6 - SN:1380

Calibration procedure(s): QA CAL-01.v9, QA CAL-12.v9, QA CAL-23.v5, QA CAL-25.v6
Calibration procedure for dosimetric E-field probes

Calibration date: December 13, 2013

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	04-Apr-13 (No. 217-01733)	Apr-14
Power sensor E4412A	MY41498087	04-Apr-13 (No. 217-01733)	Apr-14
Reference 3 dB Attenuator	SN: S5054 (3c)	04-Apr-13 (No. 217-01737)	Apr-14
Reference 20 dB Attenuator	SN: S5277 (20x)	04-Apr-13 (No. 217-01735)	Apr-14
Reference 30 dB Attenuator	SN: S5129 (30b)	04-Apr-13 (No. 217-01738)	Apr-14
Reference Probe ES3DV2	SN: 3013	28-Dec-12 (No. ES3-3013_Dec12)	Dec-13
DAE4	SN: 660	13-Dec-13 (No. DAE4-660_Dec13)	Dec-14
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Apr-13)	In house check: Apr-15
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-13)	In house check: Oct-14

	Name	Function	Signature
Calibrated by:	Claudio Leubler	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: December 14, 2013

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: ET3-1380_Dec13 Page 1 of 11

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Glossary:

TSL	tissue simulating liquid
NORMx,y,z	sensitivity in free space
ConvF	sensitivity in TSL / NORMx,y,z
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., ϑ = 0 is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- *NORMx,y,z:* Assessed for E-field polarization ϑ = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not affect the E^2-field uncertainty inside TSL (see below *ConvF*).
- *NORM(f)x,y,z = NORMx,y,z * frequency_response* (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- *DCPx,y,z:* DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- *PAR:* PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- *Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D* are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. *VR* is the maximum calibration range expressed in RMS voltage across the diode.
- *ConvF and Boundary Effect Parameters:* Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to *NORMx,y,z * ConvF* whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- *Spherical isotropy (3D deviation from isotropy)*: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- *Connector Angle*: The angle is assessed using the information gained by determining the *NORMx* (no uncertainty required).

Probe ET3DV6

SN:1380

Manufactured: August 16, 1999
Calibrated: December 13, 2013

Calibrated for DASY/EASY Systems
(Note: non-compatible with DASY2 system!)

ET3DV6– SN:1380 December 13, 2013

DASY/EASY - Parameters of Probe: ET3DV6 - SN:1380

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu V/(V/m)^2$)[A]	1.68	1.60	1.71	± 10.1 %
DCP (mV)[B]	94.2	94.3	95.1	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dB√μV	C	D dB	VR mV	Unc[E] (k=2)
0	CW	X	0.0	0.0	1.0	0.00	236.5	±2.2 %
		Y	0.0	0.0	1.0		191.3	
		Z	0.0	0.0	1.0		246.5	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

[A] The uncertainties of NormX,Y,Z do not affect the E^2-field uncertainty inside TSL (see Pages 5 and 6).
[B] Numerical linearization parameter: uncertainty not required.
[E] Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

DASY/EASY - Parameters of Probe: ET3DV6 - SN:1380

Calibration Parameter Determined in Head Tissue Simulating Media

f (MHz) [C]	Relative Permittivity [F]	Conductivity (S/m) [F]	ConvF X	ConvF Y	ConvF Z	Alpha [G]	Depth [G] (mm)	Unct. (k=2)
300	45.3	0.87	7.77	7.77	7.77	0.23	2.38	± 13.3 %
450	43.5	0.87	7.31	7.31	7.31	0.27	2.84	± 13.3 %
750	41.9	0.89	6.65	6.65	6.65	0.65	1.90	± 12.0 %
900	41.5	0.97	5.91	5.91	5.91	0.45	2.35	± 12.0 %
1640	40.3	1.29	5.25	5.25	5.25	0.58	2.51	± 12.0 %
1810	40.0	1.40	5.04	5.04	5.04	0.80	2.08	± 12.0 %
1950	40.0	1.40	4.83	4.83	4.83	0.80	2.09	± 12.0 %
2450	39.2	1.80	4.43	4.43	4.43	0.80	1.73	± 12.0 %

[C] Frequency validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.
[F] At frequencies below 3 GHz, the validity of tissue parameters (ε and σ) can be relaxed to ± 10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ε and σ) is restricted to ± 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.
[G] Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

DASY/EASY - Parameters of Probe: ET3DV6 - SN:1380

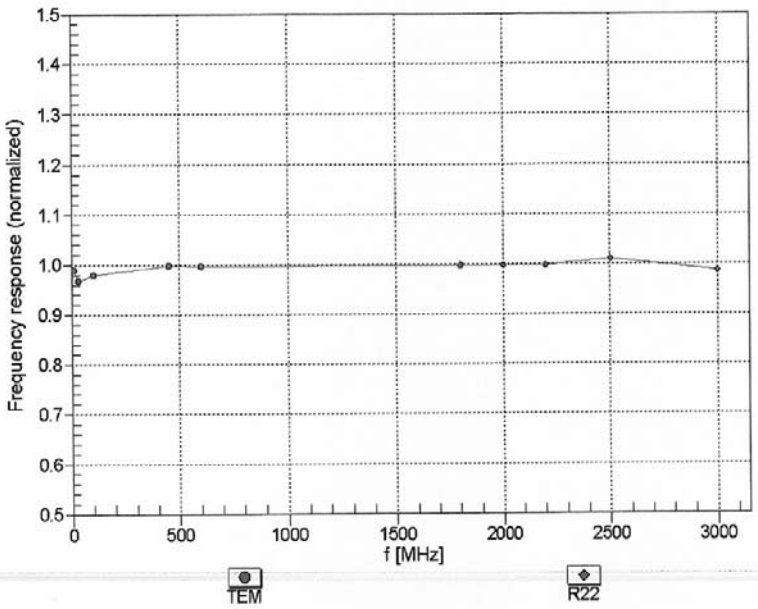
Calibration Parameter Determined in Body Tissue Simulating Media

f (MHz) [C]	Relative Permittivity [F]	Conductivity (S/m) [F]	ConvF X	ConvF Y	ConvF Z	Alpha [G]	Depth [G] (mm)	Unct. (k=2)
450	56.7	0.94	7.49	7.49	7.49	0.22	2.35	± 13.3 %
750	55.5	0.96	6.01	6.01	6.01	0.49	2.13	± 12.0 %
900	55.0	1.05	5.86	5.86	5.86	0.45	2.47	± 12.0 %
1810	53.3	1.52	4.68	4.68	4.68	0.80	2.33	± 12.0 %
1950	53.3	1.52	4.67	4.67	4.67	0.80	2.29	± 12.0 %
2450	52.7	1.95	4.12	4.12	4.12	0.63	1.10	± 12.0 %

[C] Frequency validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.
[F] At frequencies below 3 GHz, the validity of tissue parameters (ε and σ) can be relaxed to ± 10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ε and σ) is restricted to ± 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.
[G] Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

ET3DV6– SN:1380 December 13, 2013

Frequency Response of E-Field
(TEM-Cell:ifi110 EXX, Waveguide: R22)

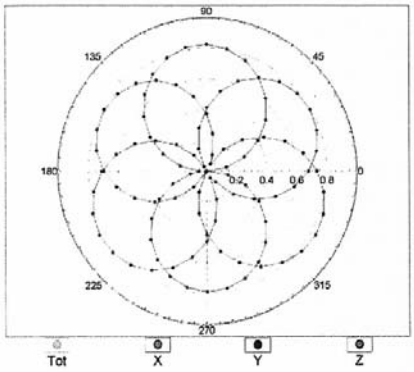


Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

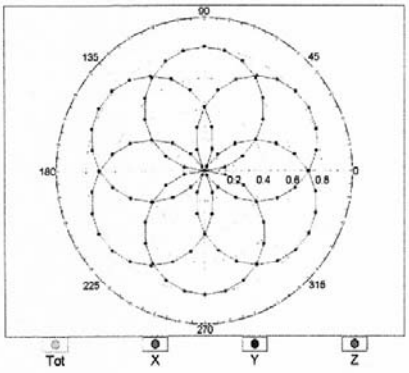
ET3DV6– SN:1380 December 13, 2013

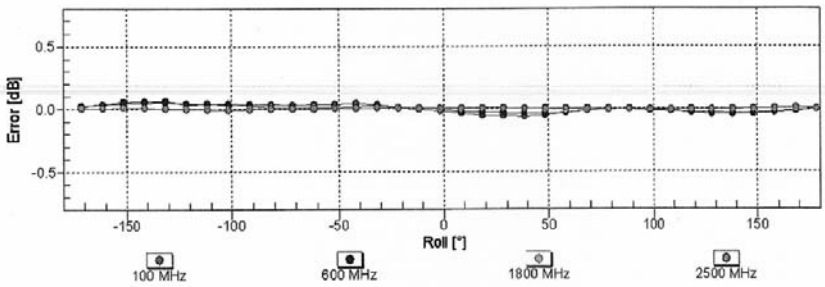
Receiving Pattern (ϕ), ϑ = 0°

f=600 MHz,TEM



f=1800 MHz,R22



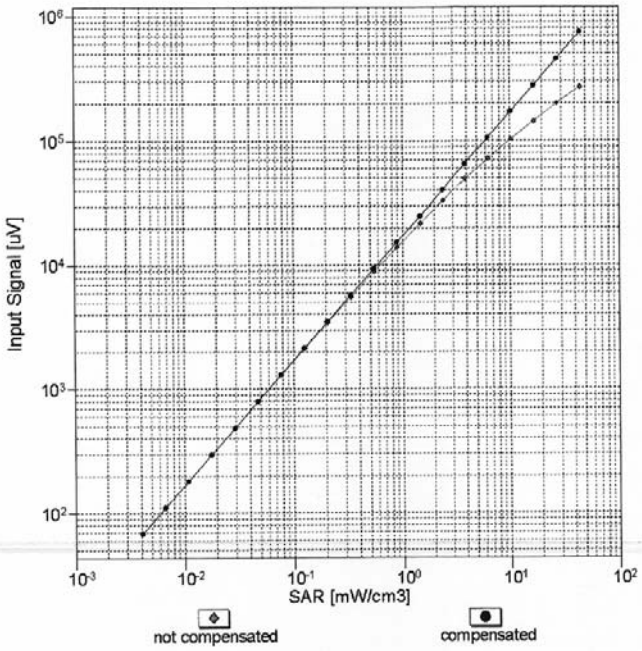


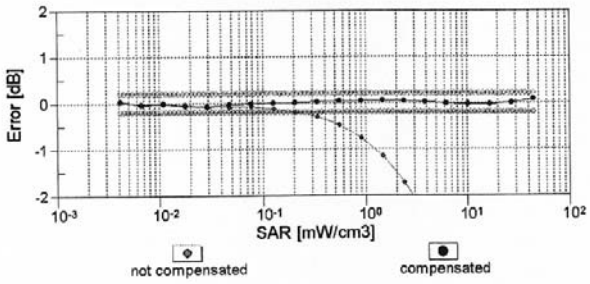
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Certificate No: ET3-1380_Dec13 Page 8 of 11

ET3DV6– SN:1380 December 13, 2013

Dynamic Range f(SAR_{head})
(TEM cell , f = 900 MHz)





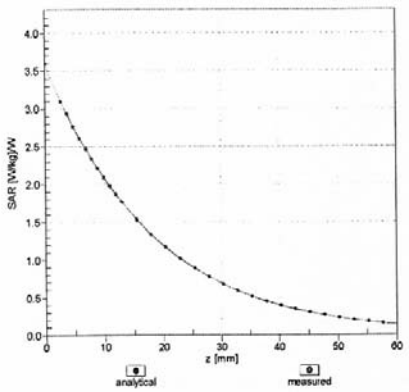
Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Certificate No: ET3-1380_Dec13 Page 9 of 11

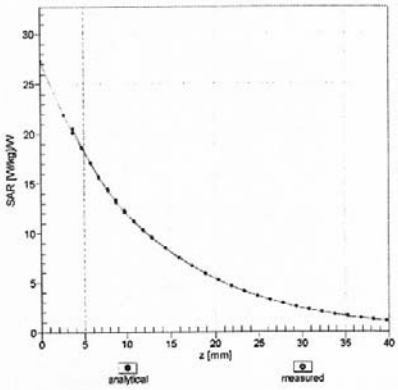
ET3DV6– SN:1380 December 13, 2013

Conversion Factor Assessment

f = 900 MHz,WGLS R9 (H_convF)

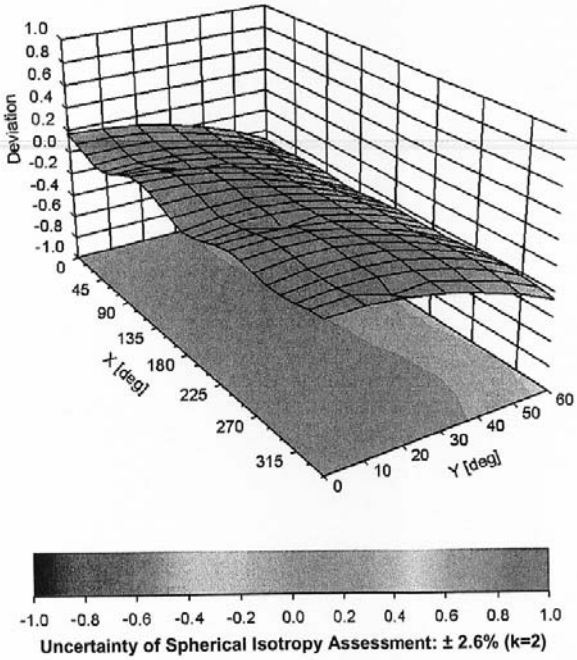


f = 1810 MHz,WGLS R22 (H_convF)



Deviation from Isotropy in Liquid

Error (ϕ, ϑ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

DASY/EASY - Parameters of Probe: ET3DV6 - SN:1380

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	-21.7
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	6.8 mm
Probe Tip to Sensor X Calibration Point	2.7 mm
Probe Tip to Sensor Y Calibration Point	2.7 mm
Probe Tip to Sensor Z Calibration Point	2.7 mm
Recommended Measurement Distance from Surface	4 mm

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Accreditation No.: SCS 108

Client **EMC Technologies**

Certificate No: D900V2-047_Jun12

CALIBRATION CERTIFICATE

Object	D900V2 - SN: 047
Calibration procedure(s)	QA CAL-05.v8 Calibration procedure for dipole validation kits above 700 MHz
Calibration date:	June 22, 2012

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	05-Oct-11 (No. 217-01451)	Oct-12
Power sensor HP 8481A	US37292783	05-Oct-11 (No. 217-01451)	Oct-12
Reference 20 dB Attenuator	SN: 5058 (20k)	27-Mar-12 (No. 217-01530)	Apr-13
Type-N mismatch combination	SN: 5047.2 / 06327	27-Mar-12 (No. 217-01533)	Apr-13
Reference Probe ES3DV3	SN: 3205	30-Dec-11 (No. ES3-3205_Dec11)	Dec-12
DAE4	SN: 901	05-Jul-11 (No. DAE4-901_Jul11)	Jul-12

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-11)	In house check: Oct-13
RF generator R&S SMT-06	100005	04-Aug-99 (in house check Oct-11)	In house check: Oct-13
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-11)	In house check: Oct-12

	Name	Function	Signature
Calibrated by:	Dimce Iliev	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: June 22, 2012

Calibration Laboratory of
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Accreditation No.: SCS 108

Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.1
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	900 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.97 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	40.3 ± 6 %	0.95 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C	----	----

SAR result with Head TSL

SAR averaged over 1 cm³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.63 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	**10.6 mW /g ± 17.0 % (k=2)**

SAR averaged over 10 cm³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	1.69 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	**6.81 mW /g ± 16.5 % (k=2)**

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	55.0	1.05 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	52.9 ± 6 %	1.06 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C	----	----

SAR result with Body TSL

SAR averaged over 1 cm³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	2.83 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	**11.1 mW / g ± 17.0 % (k=2)**

SAR averaged over 10 cm³ (10 g) of Body TSL	condition	
SAR measured	250 mW input power	1.81 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	**7.16 mW / g ± 16.5 % (k=2)**

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	52.1 Ω - 3.9 jΩ
Return Loss	- 27.3 dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	48.5 Ω - 5.3 jΩ
Return Loss	- 25.1 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.410 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard.
No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	October 07, 1998

DASY5 Validation Report for Head TSL

Date: 22.06.2012

Test Laboratory: SPEAG, Zurich, Switzerland

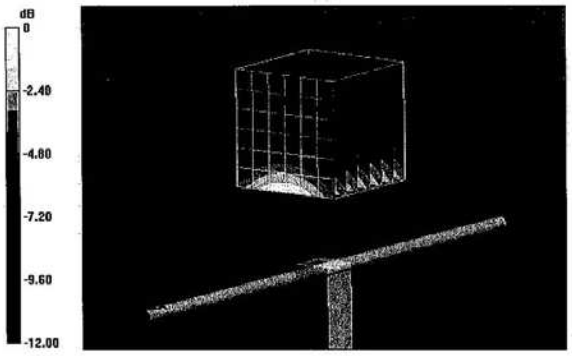
DUT: Dipole 900 MHz; Type: D900V2; Serial: D900V2 - SN: 047

Communication System: CW; Frequency: 900 MHz
Medium parameters used: f = 900 MHz; σ = 0.95 mho/m; ε_r = 40.3; ρ = 1000 kg/m^3
Phantom section: Flat Section
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

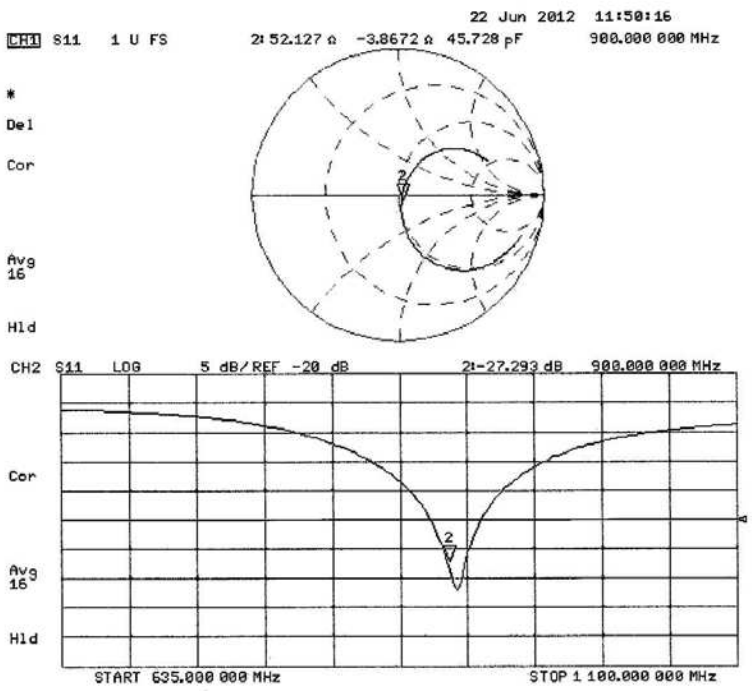
- Probe: ES3DV3 - SN3205; ConvF(5.97, 5.97, 5.97); Calibrated: 30.12.2011;
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn901; Calibrated: 05.06.2012
- Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001
- DASY52 52.8.1(838); SEMCAD X 14.6.5(6469)

Dipole Calibration for Head Tissue/Pin=250 mW, d=15mm/Zoom Scan (7x7x7)/Cube 0:
Measurement grid: dx=5mm, dy=5mm, dz=5mm
Reference Value = 58.816 V/m; Power Drift = -0.00 dB
Peak SAR (extrapolated) = 3.956 mW/g
SAR(1 g) = 2.63 mW/g; SAR(10 g) = 1.69 mW/g
Maximum value of SAR (measured) = 3.09 mW/g



0 dB = 3.09 mW/g = 9.80 dB mW/g

Impedance Measurement Plot for Head TSL



Certificate No: D900V2-047_Jun12 Page 6 of 8

DASY5 Validation Report for Body TSL

Date: 22.06.2012

Test Laboratory: SPEAG, Zurich, Switzerland

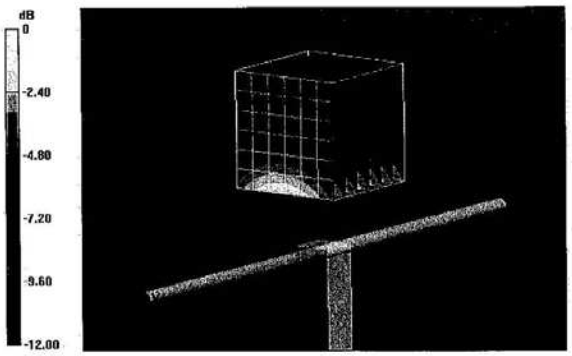
DUT: Dipole 900 MHz; Type: D900V2; Serial: D900V2 - SN: 047

Communication System: CW; Frequency: 900 MHz
Medium parameters used: f = 900 MHz; σ = 1.06 mho/m; ε_r = 52.9; ρ = 1000 kg/m^3
Phantom section: Flat Section
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

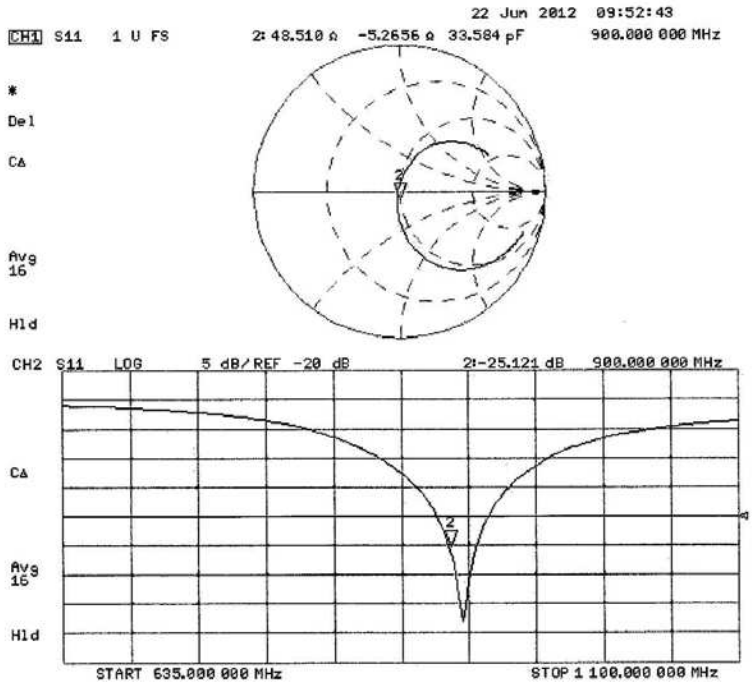
- Probe: ES3DV3 - SN3205; ConvF(5.94, 5.94, 5.94); Calibrated: 30.12.2011;
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn901; Calibrated: 05.06.2012
- Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001
- DASY52 52.8.1(838); SEMCAD X 14.6.5(6469)

Dipole Calibration for Body Tissue/Pin=250 mW, d=15mm/Zoom Scan (7x7x7)/Cube 0:
Measurement grid: dx=5mm, dy=5mm, dz=5mm
Reference Value = 57.369 V/m; Power Drift = 0.00 dB
Peak SAR (extrapolated) = 4.370 mW/g
SAR(1 g) = 2.83 mW/g; SAR(10 g) = 1.81 mW/g
Maximum value of SAR (measured) = 3.32 mW/g



0 dB = 3.32 mW/g = 10.42 dB mW/g

Impedance Measurement Plot for Body TSL



Certificate No: D900V2-047_Jun12 Page 8 of 8

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Client EMC Technologies

Certificate No: D1950V3-1113_Dec12

CALIBRATION CERTIFICATE

Object	D1950V3 - SN: 1113
Calibration procedure(s)	QA CAL-05.v8 Calibration procedure for dipole validation kits above 700 MHz
Calibration date:	December 06, 2012

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	01-Nov-12 (No. 217-01640)	Oct-13
Power sensor HP 8481A	US37292783	01-Nov-12 (No. 217-01640)	Oct-13
Reference 20 dB Attenuator	SN: 5058 (20k)	27-Mar-12 (No. 217-01530)	Apr-13
Type-N mismatch combination	SN: 5047.3 / 06327	27-Mar-12 (No. 217-01533)	Apr-13
Reference Probe ES3DV3	SN: 3205	30-Dec-11 (No. ES3-3205_Dec11)	Dec-12
DAE4	SN: 601	27-Jun-12 (No. DAE4-601_Jun12)	Jun-13

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-11)	In house check: Oct-13
RF generator R&S SMT-06	100005	04-Aug-99 (in house check Oct-11)	In house check: Oct-13
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-12)	In house check: Oct-13

	Name	Function	Signature
Calibrated by:	Israe El-Naouq	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: December 6, 2012

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Certificate No: D1950V3-1113_Dec12 Page 1 of 8

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Accreditation No.: SCS 108

Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.3
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1950 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	**Permittivity**	**Conductivity**
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.3 ± 6 %	1.43 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C	----	----

SAR result with Head TSL

SAR averaged over 1 cm^3 (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	10.4 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	**40.9 W/kg ± 17.0 % (k=2)**

SAR averaged over 10 cm^3 (10 g) of Head TSL	condition	
SAR measured	250 mW input power	5.37 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	**21.3 W/kg ± 16.5 % (k=2)**

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	**Permittivity**	**Conductivity**
Nominal Body TSL parameters	22.0 °C	53.3	1.52 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	52.1 ± 6 %	1.57 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C	----	----

SAR result with Body TSL

SAR averaged over 1 cm^3 (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	9.89 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	**38.6 W/kg ± 17.0 % (k=2)**

SAR averaged over 10 cm^3 (10 g) of Body TSL	condition	
SAR measured	250 mW input power	5.13 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	**20.2 W/kg ± 16.5 % (k=2)**

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	50.2 Ω + 0.0 jΩ
Return Loss	- 54.8 dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	46.0 Ω - 0.1 jΩ
Return Loss	- 27.7 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.191 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard.
No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	October 20, 2006

DASY5 Validation Report for Head TSL

Date: 06.12.2012

Test Laboratory: SPEAG, Zurich, Switzerland

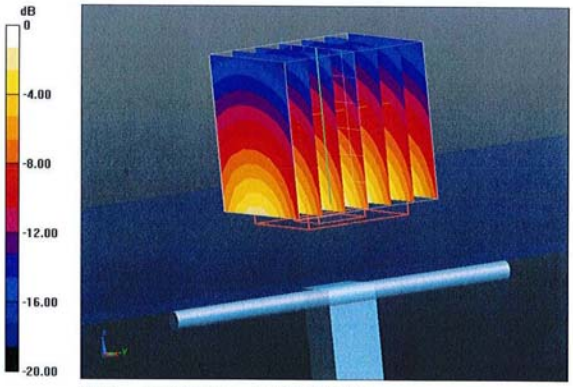
DUT: Dipole 1950 MHz; Type: D1950V3; Serial: D1950V3 - SN: 1113

Communication System: CW; Frequency: 1950 MHz
Medium parameters used: f = 1950 MHz; σ = 1.43 mho/m; ε_r = 39.3; ρ = 1000 kg/m^3
Phantom section: Flat Section
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(4.86, 4.86, 4.86); Calibrated: 30.12.2011;
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 27.06.2012
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- DASY52 52.8.3(988); SEMCAD X 14.6.7(6848)

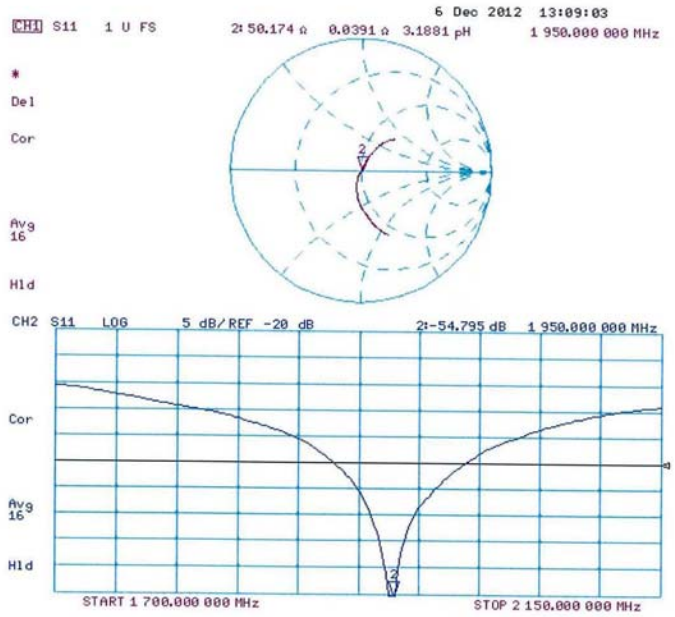
Dipole Calibration for Head Tissue/Pin=250 mW, d=10mm/Zoom Scan (7x7x7)/Cube 0:
Measurement grid: dx=5mm, dy=5mm, dz=5mm
Reference Value = 98.036 V/m; Power Drift = 0.05 dB
Peak SAR (extrapolated) = 18.8 W/kg
SAR(1 g) = 10.4 W/kg; SAR(10 g) = 5.37 W/kg
Maximum value of SAR (measured) = 12.8 W/kg



0 dB = 12.8 W/kg = 11.07 dBW/kg

Certificate No: D1950V3-1113_Dec12 Page 5 of 8

Impedance Measurement Plot for Head TSL



DASY5 Validation Report for Body TSL

Date: 06.12.2012

Test Laboratory: SPEAG, Zurich, Switzerland

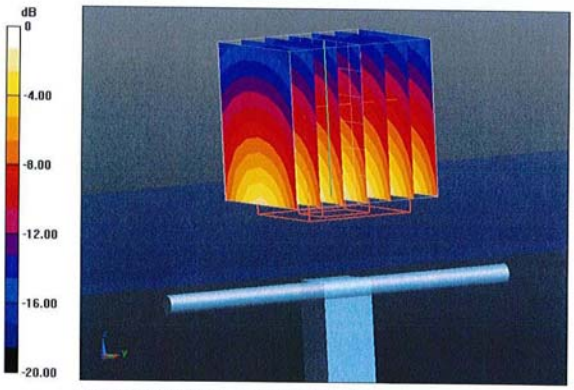
DUT: Dipole 1950 MHz; Type: D1950V3; Serial: D1950V3 - SN: 1113

Communication System: CW; Frequency: 1950 MHz
Medium parameters used: f = 1950 MHz; σ = 1.57 mho/m; ε_r = 52.1; ρ = 1000 kg/m^3
Phantom section: Flat Section
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

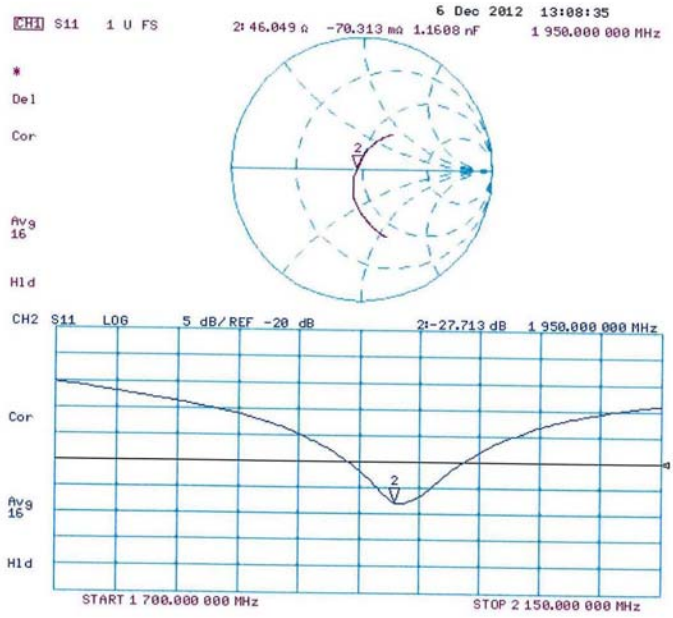
- Probe: ES3DV3 - SN3205; ConvF(4.73, 4.73, 4.73); Calibrated: 30.12.2011;
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 27.06.2012
- Phantom: Flat Phantom 5.0 (back); Type: QD000P50AA; Serial: 1002
- DASY52 52.8.3(988); SEMCAD X 14.6.7(6848)

Dipole Calibration for Body Tissue/Pin=250 mW, d=10mm/Zoom Scan (7x7x7)/Cube 0:
Measurement grid: dx=5mm, dy=5mm, dz=5mm
Reference Value = 93.722 V/m; Power Drift = -0.03 dB
Peak SAR (extrapolated) = 17.7 W/kg
SAR(1 g) = 9.89 W/kg; SAR(10 g) = 5.13 W/kg
Maximum value of SAR (measured) = 12.6 W/kg



0 dB = 12.6 W/kg = 11.00 dBW/kg

Impedance Measurement Plot for Body TSL



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Client EMC Technologies **Certificate No: DAE3-442_Dec13**

CALIBRATION CERTIFICATE

Object	DAE3 - SD 000 D03 AE - SN: 442
Calibration procedure(s)	QA CAL-06.v26 Calibration procedure for the data acquisition electronics (DAE)
Calibration date:	December 10, 2013

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	01-Oct-13 (No:13976)	Oct-14
Secondary Standards	**ID #**	**Check Date (in house)**	**Scheduled Check**
Auto DAE Calibration Unit	SE UWS 053 AA 1001	07-Jan-13 (in house check)	In house check: Jan-14
Calibrator Box V2.1	SE UMS 006 AA 1002	07-Jan-13 (in house check)	In house check: Jan-14

	Name	Function	Signature
Calibrated by:	Dominique Steffen	Technician	
Approved by:	Fin Bomholt	Deputy Technical Manager	

Issued: December 10, 2013

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Certificate No: DAE3-442_Dec13 Page 1 of 5

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Accreditation No.: SCS 108

Glossary

DAE	data acquisition electronics
Connector angle	information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle*: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
  - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
  - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
  - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
  - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
  - *Input Offset Measurement*: Output voltage and statistical results over a large number of zero voltage measurements.
  - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
  - *Input resistance:* Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
  - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
  - *Power consumption:* Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range:	1LSB =	6.1µV ,	full range =	-100...+300 mV
Low Range:	1LSB =	61nV ,	full range =	-1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.392 ± 0.02% (k=2)	405.041 ± 0.02% (k=2)	405.256 ± 0.02% (k=2)
Low Range	3.98875 ± 1.50% (k=2)	3.98112 ± 1.50% (k=2)	3.99059 ± 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	107.5 ° ± 1 °

Appendix

1. DC Voltage Linearity

High Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	199993.72	-2.14	-0.00
Channel X	+ Input	20000.86	0.45	0.00
Channel X	- Input	-19999.17	2.02	-0.01
Channel Y	+ Input	199996.31	0.40	0.00
Channel Y	+ Input	19999.51	-1.10	-0.01
Channel Y	- Input	-19999.92	1.09	-0.01
Channel Z	+ Input	199995.50	-0.37	-0.00
Channel Z	+ Input	20000.62	0.18	0.00
Channel Z	- Input	-20000.78	0.43	-0.00

Low Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	2000.89	0.19	0.01
Channel X	+ Input	201.15	0.18	0.09
Channel X	- Input	-197.88	0.92	-0.46
Channel Y	+ Input	2000.21	-0.38	-0.02
Channel Y	+ Input	200.77	-0.15	-0.08
Channel Y	- Input	-200.31	-1.40	0.70
Channel Z	+ Input	1999.91	-0.68	-0.03
Channel Z	+ Input	200.63	-0.29	-0.14
Channel Z	- Input	-199.19	-0.34	0.17

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	-9.24	-11.23
	- 200	12.06	10.58
Channel Y	200	0.76	0.40
	- 200	-1.54	-1.84
Channel Z	200	-5.26	-5.50
	- 200	2.39	2.43

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	-0.05	-4.04
Channel Y	200	8.61	-	0.53
Channel Z	200	7.15	6.59	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15799	16180
Channel Y	15773	16313
Channel Z	15591	16683

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec
Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	-0.26	-1.81	1.47	0.63
Channel Y	0.14	-1.39	1.41	0.60
Channel Z	-3.02	-4.46	-1.61	0.67

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9